

TRF37x32 具有集成 IF 放大器的双通道下变频混频器

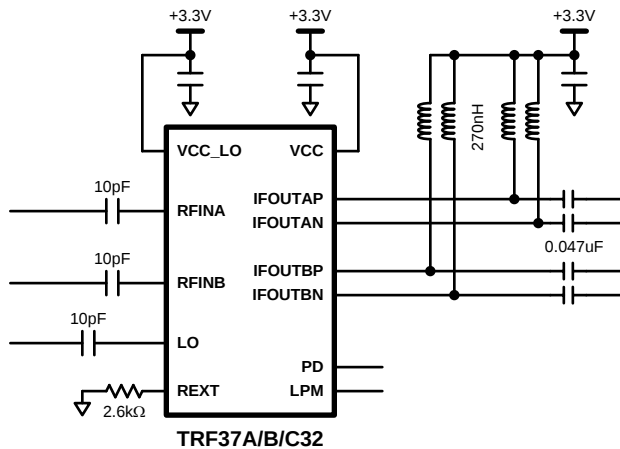
1 特性

- 此器件系列支持宽射频输入范围
 - TRF37A32: 400 - 1700MHz
 - TRF37B32: 700 - 2700MHz
 - TRF37C32: 1700 - 3800MHz
- 增益: 10dB
- 噪声系数: 9.5dB
- 输入 IP3: 30dBm
- 每通道 500mW 功耗
- 单端射频输入
- 中频频率范围为 30MHz 至 600MHz
- 通道间 45dB 隔离
- 低功耗模式选项
- 独立的断电控制
- 3.3V 单电源
- 无需外部匹配组件

2 应用

- 无线基础设施
 - WCDMA, TD-SCDMA
 - LTE, TD-LTE
 - 多载波 GSM (MC-GSM)
- 点对点微波回程
- 软件定义无线电 (SDR)
- 雷达接收器
- 卫星通信

4 简化电路原理图



3 说明

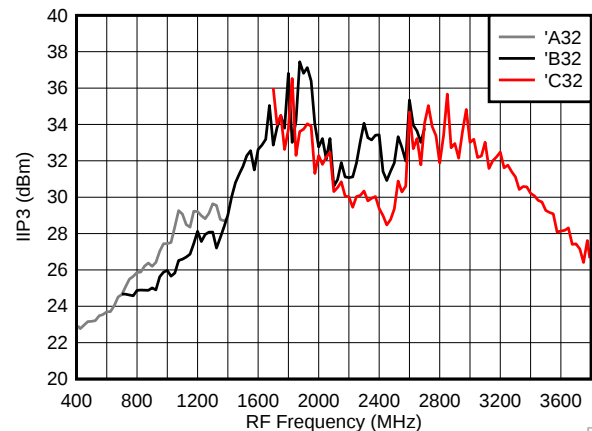
TRF37x32 是具有集成中频放大器的宽带双通道下变频混频器。该器件采用集成式平衡-非平衡变压器进行单端射频和 LO 输入。中频放大器在集电极开路拓扑结构中的工作频率为 30MHz 至 600MHz，支持多种中频频率和带宽。TRF37x32 提供出色的混频器线性度和噪声性能，并在通道间提供良好的隔离，以便用于多种应用。该器件具有低功耗特性，此外还为功率敏感型应用提供了低功耗模式选项。各个通道均可单独降频并快速响应，因而非常适用于时域双工 (TDD) 应用。

器件信息⁽¹⁾

器件型号	封装	封装尺寸 (标称值)
TRF37A32	WQFN (32)	5.00mm x 5.00mm
TRF37B32		
TRF37C32		

(1) 要了解所有可用封装，请见数据表末尾的可订购产品附录。

频率间的 IIP3 性能



00001



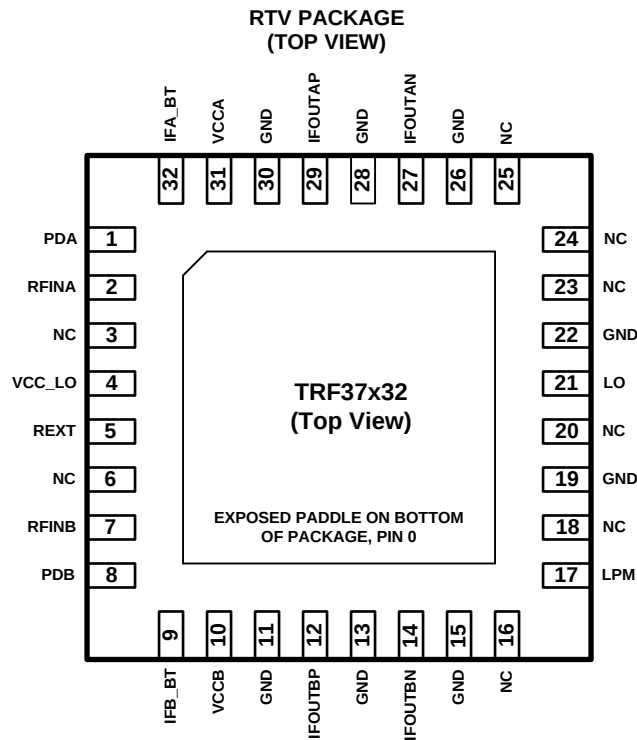
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5 修订历史记录

Changes from Original (May 2014) to Revision A	Page
• 添加了典型特征，特性描述部分，器件功能模式，应用和实施部分，电源相关建议部分和布局部分	1
• Replaced the <i>Handling Ratings</i> table with the <i>ESD Ratings</i> table	5

6 Pin Configuration and Functions



Pin Functions

PIN		I/O	DESCRIPTION
NAME	NO.		
PDA	1	Digital Input	Power down for channel A (1 = PD; 0 or open = powered)
RFINA	2	Analog Input	RF input for channel A
NC	3	N/A	No connect
VCC_LO	4	Supply	V _{CC} supply for the LO circuitry
REXT	5	Bias	External bias resistor
NC	6	N/A	No connect
RFINB	7	Analog Input	RF input for channel B
PDB	8	Digital Input	Power down for channel B (1 = PD; 0 or open = powered)
IFB_BT	9	N/A	IF channel B bias control; leave unconnected
VCCB	10	Supply	Power supply for channel B
GND	11	Ground	Ground
IFOUTBP	12	Analog Output	IF out channel B: positive
GND	13	Ground	Ground
IFOUTBN	14	Analog Output	IF out channel B: negative
GND	15	Ground	Ground
NC	16	N/A	No connect
LPM	17	Digital Input	Low power mode (0 = normal; 1 = low power)
NC	18	N/A	No connect
GND	19	Ground	Ground
NC	20	N/A	No connect
LO	21	Analog Input	Local oscillator (LO) input

TRF37A32, TRF37B32, TRF37C32

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Pin Functions (continued)

PIN		I/O	DESCRIPTION
NAME	NO.		
GND	22	Ground	Ground
NC	23	N/A	No connect
NC	24	N/A	No connect
NC	25	N/A	No connect
GND	26	Ground	Ground
IFOUTAN	27	Analog Output	IF out channel A: negative
GND	28	Ground	Ground
IFOUTAP	29	Analog Output	IF out channel A: positive
GND	30	Ground	Ground
VCCA	31	Supply	Power supply for channel A
IFA_BT	32	N/A	IF channel A bias control; leave unconnected

7 Specifications

7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) ⁽¹⁾

	MIN	MAX	UNIT
Input voltage	–0.3	3.6	V
Storage temperature, T _{STG}	–40	150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

7.2 ESD Ratings

			VALUE	UNIT
V _(ESD) Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	All pins except XIFOUTAP, IFOUTAN, IFOUTBP, and IFOUTBN	±2500	V
		Pins XIFOUTAP, IFOUTAN, IFOUTBP, and IFOUTBN ⁽²⁾	±100	
	Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽³⁾		±1000	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

- (2) High Linearity IFOUT pins are susceptible to low voltage HBM damage.

- (3) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

	MIN	NOM	MAX	UNIT
Operating virtual junction temperature range, T _J	–40		125	°C

7.4 Thermal Information

THERMAL METRIC ⁽¹⁾		RTV	UNIT
		32 PINS	
R _{θJA}	Junction-to-ambient thermal resistance	32.3	°C/W
R _{θJCTop}	Junction-to-case (top) thermal resistance	19.8	
R _{θJB}	Junction-to-board thermal resistance	5.9	
Ψ _{JT}	Junction-to-top characterization parameter	0.2	
Ψ _{JB}	Junction-to-board characterization parameter	5.9	
R _{θJCbott}	Junction-to-case (bottom) thermal resistance	1.3	

- (1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, [SPRA953](#).

TRF37A32, TRF37B32, TRF37C32

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7.5 Electrical Characteristics, TRF37A32
 $T_A = 25^\circ\text{C}$, $V_{CC} = 3.3\text{ V}$; $P_{RF} = -10\text{ dBm}$; $P_{LO} = 0\text{ dBm}$; $F_{IF} = 200\text{ MHz}$; Low Side Injection, $LPM = 0$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
DC Parameters						
V_{CC}	Supply Voltage		3.15	3.3	3.45	V
I_{CC}	Supply Current	$F_{LO} = 750\text{ MHz}$		280		mA
P_{diss}	Total Power Dissipation	$F_{LO} = 750\text{ MHz}$		0.92		W
	Power Down Current				2	mA
RF Frequency Range						
F_{RF}	Frequency Range		400		1700	MHz
RF Specifications						
G	Gain	$F_{RF} = 950\text{ MHz (LSI)}$		9.6		dB
G_{var}	Gain Variation over Frequency	within any 200 MHz Band		0.5		dB
NF	SSB Noise Figure	$F_{RF} = 950\text{ MHz (LSI)}$		9.6		dB
	SSB Noise Figure with Blocker	5 dBm blocker signal $\Delta f > 50\text{ MHz}$		17		dB
IIP3	Input 3rd Order Intercept Point	$F_{RF} = 950\text{ MHz (LSI)}$, $F_{spacing} = 20\text{ MHz}$		26		dBm
OIP3	Output 3rd Order Intercept Point	$F_{RF} = 950\text{ MHz (LSI)}$, $F_{spacing} = 20\text{ MHz}$		35.6		dBm
OIP2	Output 2nd Order Intercept Point	$F_{RF} = 950\text{ MHz (LSI)}$		65		dBm
IP1dB	Input 1 dB Compression Point	$F_{RF} = 950\text{ MHz (LSI)}$		11		dBm
Z_{IN}	Input Impedance			50		Ω
RLi	Input Return Loss	$F_{RF} = 800 - 1400\text{ MHz (LSI)}$		15		dB
LO Input						
P_{LO}	LO Drive Level		-3	0	6	dBm
F_{LO}	LO Frequency Range		600		1400	MHz
Z_{IN}	Input Impedance			50		Ω
RLi	Input Return Loss	$F_{RF} = 750 - 1150\text{ MHz}$		15		dB
Low Power Mode: LPM = 1						
I_{CC}	Supply Current	$F_{LO} = 750\text{ MHz}$		200		mA
P_{diss}	Total Power Dissipation	$F_{LO} = 750\text{ MHz}$		0.66		W
G	Gain	$F_{RF} = 950\text{ MHz (LSI)}$		9.2		dB
NF	SSB Noise Figure	$F_{RF} = 950\text{ MHz (LSI)}$		9.6		dB
IIP3	Input 3rd Order Intercept Point	$F_{RF} = 950\text{ MHz (LSI)}$, $F_{spacing} = 20\text{ MHz}$		26		dBm
IP1dB	Input 1 dB Compression Point	$F_{RF} = 950\text{ MHz (LSI)}$		11		dBm
Isolation						
	Channel Isolation	Drive RFinA/B IFoutA/B-IFoutB/A $F_{RF} = 950\text{ MHz}$		50		dB
	RF to IF Isolation	$F_{RF} = 950\text{ MHz}$		20		dB
	LO to RF Leakage	$P_{LO} = 0\text{ dBm}$		-55		dBm
	LO to IF Leakage	$P_{LO} = 0\text{ dBm}$		-45		dBm
Spurious						
	2x2 Spurious Product	2RF - 2LO		65		dBc
	3x3 Spurious Product	3RF - 3LO		70		dBc
IF Output						
Z_L	Differential Output Impedance Load			200		Ω
F_{IF}	Frequency Range	1 dB corner frequency	30		600	MHz
	DC Bias Range	Externally supplied DC bias through RF choke		3.3		V

7.6 Electrical Characteristics, TRF37B32

$T_A = 25^\circ\text{C}$, $V_{CC} = 3.3\text{ V}$; $P_{RF} = -10\text{ dBm}$; $P_{LO} = 0\text{ dBm}$; $F_{IF} = 200\text{ MHz}$; Low Side Injection, $LPM = 0$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
DC Parameters						
V_{CC}	Supply Voltage		3.15	3.3	3.45	V
I_{CC}	Supply Current	$F_{LO} = 1750\text{ MHz}$		305		mA
P_{diss}	Total Power Dissipation	$F_{LO} = 1750\text{ MHz}$		1		W
	Power Down Current				2	mA
RF Frequency Range						
F_{RF}	Frequency Range		700		2700	MHz
RF Specifications						
G	Gain	$F_{RF} = 1950\text{ MHz (LSI)}$		10		dB
G_{var}	Gain Variation over Frequency	within any 200 MHz Band		0.5		dB
NF	SSB Noise Figure	$F_{RF} = 1950\text{ MHz (LSI)}$		9.2		dB
	SSB Noise Figure with Blocker	5 dBm blocker signal $\Delta f > 50\text{ MHz}$		15.5		dB
IIP3	Input 3rd Order Intercept Point	$F_{RF} = 1950\text{ MHz (LSI)}$, $F_{spacing} = 20\text{ MHz}$		32		dBm
OIP3	Output 3rd Order Intercept Point	$F_{RF} = 1950\text{ MHz (LSI)}$, $F_{spacing} = 20\text{ MHz}$		42		dBm
OIP2	Output 2nd Order Intercept Point	$F_{RF} = 1950\text{ MHz (LSI)}$		70		dBm
IP1dB	Input 1 dB Compression Point	$F_{RF} = 1950\text{ MHz (LSI)}$		10.8		dBm
Z_{IN}	Input Impedance			50		Ω
RLi	Input Return Loss	$F_{RF} = 1700 - 2700\text{ MHz (LSI)}$		10		dB
LO Input						
P_{LO}	LO Drive Level		-3	0	6	dBm
F_{LO}	LO Frequency Range		500		2900	MHz
Z_{IN}	Input Impedance			50		Ω
RLi	Input Return Loss	$F_{RF} = 1500 - 2450\text{ MHz}$		15		dB
Low Power Mode: LPM = 1						
I_{CC}	Supply Current	$F_{LO} = 1750\text{ MHz}$		220		mA
P_{diss}	Total Power Dissipation	$F_{LO} = 1750\text{ MHz}$		0.73		W
G	Gain	$F_{RF} = 1950\text{ MHz (LSI)}$		9.2		dB
NF	SSB Noise Figure	$F_{RF} = 1950\text{ MHz (LSI)}$		9.2		dB
IIP3	Input 3rd Order Intercept Point	$F_{RF} = 1950\text{ MHz (LSI)}$, $F_{spacing} = 20\text{ MHz}$		23		dBm
IP1dB	Input 1 dB Compression Point	$F_{RF} = 1950\text{ MHz (LSI)}$		10.7		dBm
Isolation						
	Channel Isolation	Drive RFinA/B IFoutA/B-IFoutB/A $F_{RF} = 1950\text{ MHz}$		45		dB
	RF to IF Isolation	$F_{RF} = 1950\text{ MHz}$		22		dB
	LO to RF Leakage	$P_{LO} = 0\text{ dBm}$		-50		dBm
	LO to IF Leakage	$P_{LO} = 0\text{ dBm}$		-42		dBm
Spurious						
	2x2 Spurious Product	2RF - 2LO		70		dBc
	3x3 Spurious Product	3RF - 3LO		75		dBc
IF Output						
Z_L	Differential Output Impedance Load			200		Ω
F_{IF}	Frequency Range	1 dB corner frequency	30		600	MHz
	DC Bias Range	Externally supplied DC bias through RF choke		3.3		V

7.7 Electrical Characteristics, TRF37C32

$T_A = 25^\circ\text{C}$, $V_{CC} = 3.3\text{ V}$; $P_{RF} = -10\text{ dBm}$; $P_{LO} = 0\text{ dBm}$; $F_{IF} = 200\text{ MHz}$; Low Side Injection, LPM = 0 (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
DC Parameters						
V_{CC}	Supply Voltage		3.15	3.3	3.45	V
I_{CC}	Supply Current	$F_{LO} = 2300\text{ MHz}$		325		mA
P_{diss}	Total Power Dissipation	$F_{LO} = 2300\text{ MHz}$		1.1		W
	Power Down Current				2	mA
RF Frequency Range						
F_{RF}	Frequency Range		1700		3800	MHz
RF Specifications						
G	Gain	$F_{RF} = 2500\text{ MHz (LSI)}$		9.8		dB
G_{var}	Gain Variation over Frequency	within any 200 MHz Band		0.5		dB
NF	SSB Noise Figure	$F_{RF} = 2500\text{ MHz (LSI)}$		9.9		dB
	SSB Noise Figure with Blocker	5 dBm blocker signal $\Delta f > 50\text{ MHz}$		17.5		dB
IIP3	Input 3rd Order Intercept Point	$F_{RF} = 2500\text{ MHz (LSI)}$ $F_{spacing} = 20\text{ MHz}$		29		dBm
OIP3	Output 3rd Order Intercept Point	$F_{RF} = 2500\text{ MHz (LSI)}$ $F_{spacing} = 20\text{ MHz}$		38.8		dBm
OIP2	Output 2nd Order Intercept Point	$F_{RF} = 2500\text{ MHz (LSI)}$		65		dBm
IP1dB	Input 1 dB Compression Point	$F_{RF} = 2500\text{ MHz (LSI)}$		11.5		dBm
Z_{IN}	Input Impedance			50		Ω
RLi	Input Return Loss			8		dB
LO Input						
P_{LO}	LO Drive Level		-3	0	6	dBm
F_{LO}	LO Frequency Range		1500		3600	MHz
Z_{IN}	Input Impedance			50		Ω
RLi	Input Return Loss	$F_{RF} = 2800 - 3400\text{ MHz}$		10		dB
Low Power Mode: LPM = 1						
I_{CC}	Supply Current	$F_{LO} = 2300\text{ MHz}$		230		mA
P_{diss}	Total Power Dissipation	$F_{LO} = 2300\text{ MHz}$		0.76		W
G	Gain	$F_{RF} = 2500\text{ MHz (LSI)}$		9.2		dB
NF	SSB Noise Figure	$F_{RF} = 2500\text{ MHz (LSI)}$		9.9		dB
IIP3	Input 3rd Order Intercept Point	$F_{RF} = 2500\text{ MHz (LSI)}$, $F_{spacing} = 20\text{ MHz}$		22		dBm
IP1dB	Input 1 dB Compression Point	$F_{RF} = 2500\text{ MHz (LSI)}$		11.5		dBm
Isolation						
	Channel Isolation	Drive RFinA/B IFoutA/B-IFoutB/A $F_{RF} = 2500\text{ MHz}$		48		dB
	RF to IF Isolation	$F_{RF} = 2500\text{ MHz}$		21		dB
	LO to RF Leakage	$P_{LO} = 0\text{ dBm}$		-55		dBm
	LO to IF Leakage	$P_{LO} = 0\text{ dBm}$		-45		dBm
Spurious						
	2x2 Spurious Product	2RF - 2LO		65		dBc
	3x3 Spurious Product	3RF - 3LO		70		dBc
IF Output						
Z_L	Differential Output Impedance Load			200		Ω
F_{IF}	Frequency Range	1 dB corner frequency	30		600	MHz
	DC Bias Range	Externally supplied DC bias through RF choke		3.3		V

7.8 Timing Requirements

			MIN	TYP	MAX	UNIT
Power Control						
P_D	Turn-on Time	P_D = low to 90% final output power		100		ns
	Turn-off Time	P_D = high to initial output power –30 dB		100		ns

7.9 Typical Characteristics (TRF37A32)

$T_A = 25^\circ\text{C}$, $V_{CC} = 3.3\text{ V}$; $P_{RF} = -10\text{ dBm}$; $F_{RF} = 950\text{ MHz}$; $P_{LO} = 0\text{ dBm}$; $F_{IF} = 200\text{ MHz}$; Low Side Injection, LPM = 0 (unless otherwise noted)

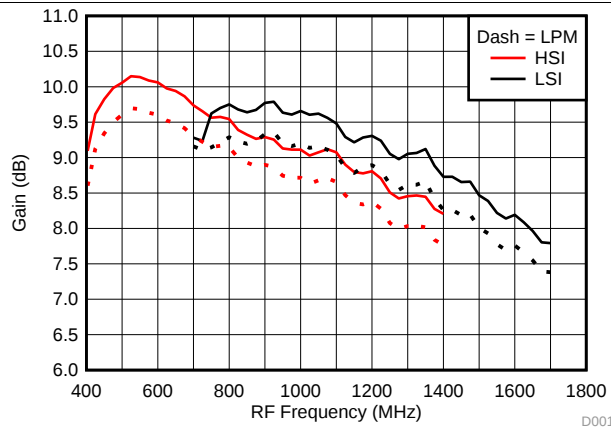


Figure 1. Gain vs Frequency over H/LSI, LPM

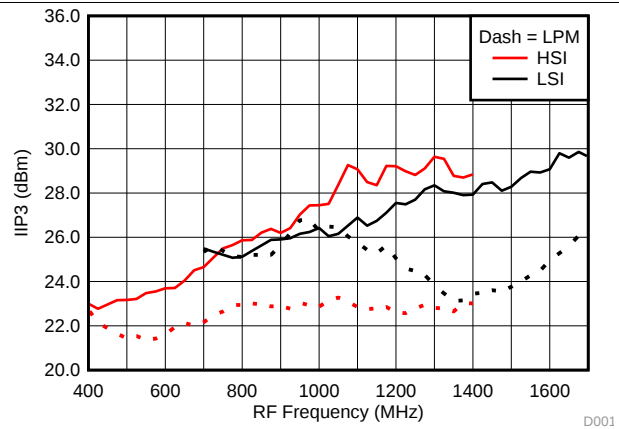


Figure 2. IIP3 vs Frequency over H/LSI, LPM

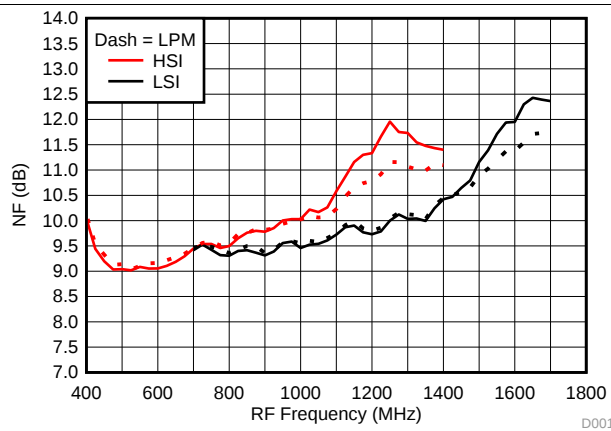


Figure 3. NF vs Frequency over H/LSI, LPM

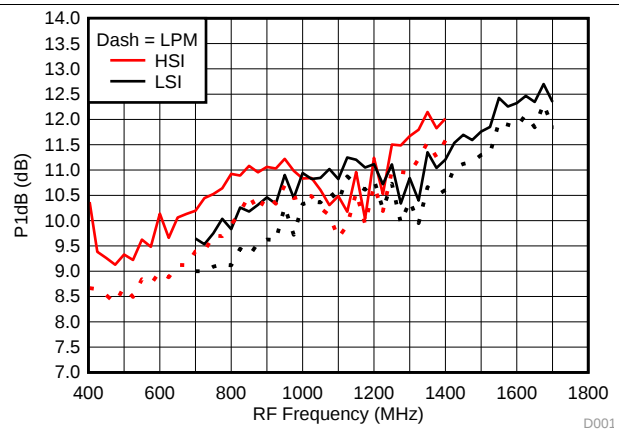


Figure 4. Input P1dB vs Frequency over H/LSI, LPM

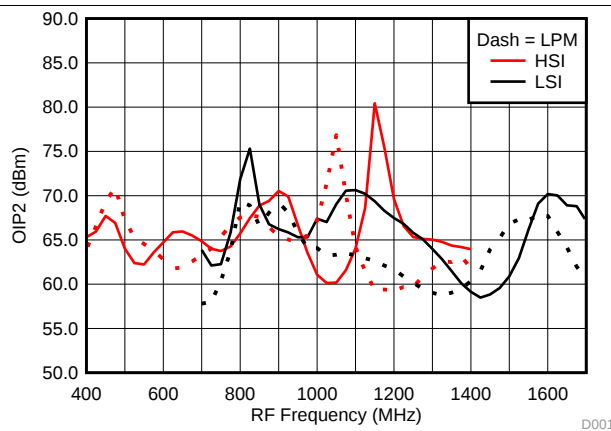


Figure 5. OIP2 vs Frequency over H/LSI, LPM

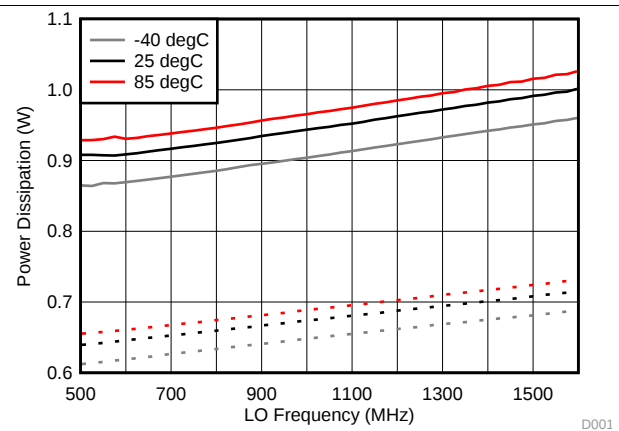


Figure 6. Power Dissipation vs Temperature, LPM

Typical Characteristics (TRF37A32) (continued)

$T_A = 25^\circ\text{C}$, $V_{CC} = 3.3\text{ V}$; $P_{RF} = -10\text{ dBm}$; $F_{RF} = 950\text{ MHz}$; $P_{LO} = 0\text{ dBm}$; $F_{IF} = 200\text{ MHz}$; Low Side Injection, LPM = 0 (unless otherwise noted)

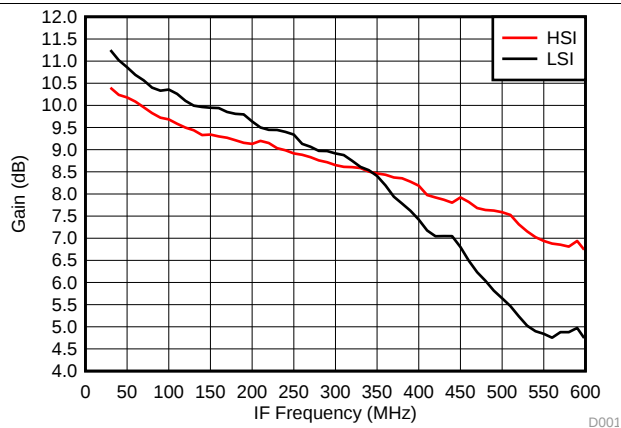


Figure 7. Gain vs IF Frequency over H/LSI

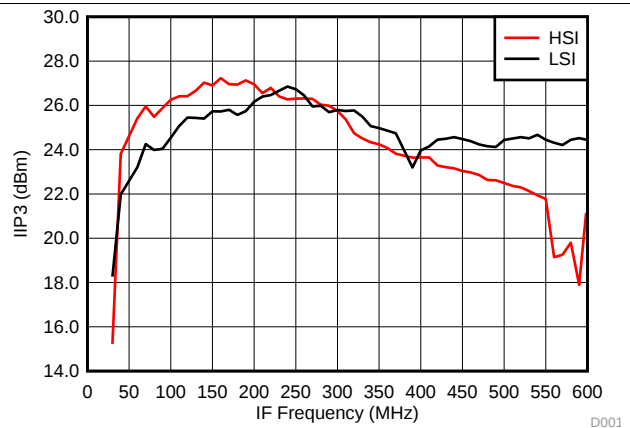


Figure 8. IIP3 vs IF Frequency over H/LSI

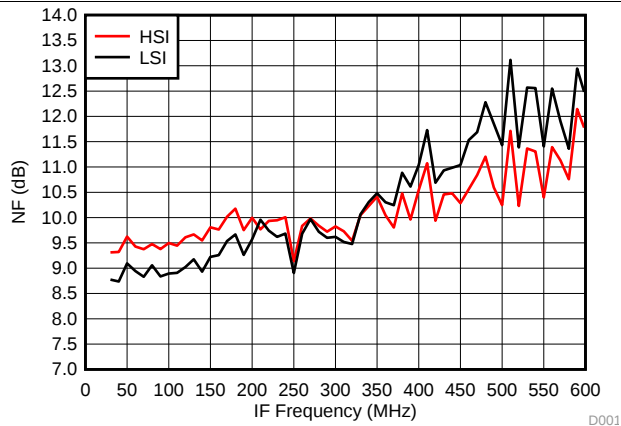


Figure 9. NF vs IF Frequency over H/LSI

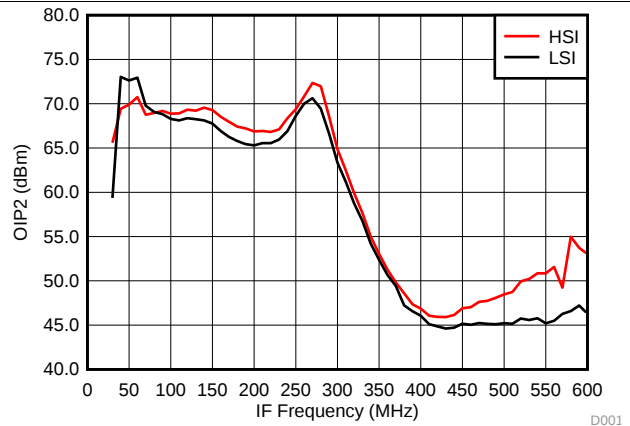


Figure 10. OIP2 vs IF Frequency over H/LSI

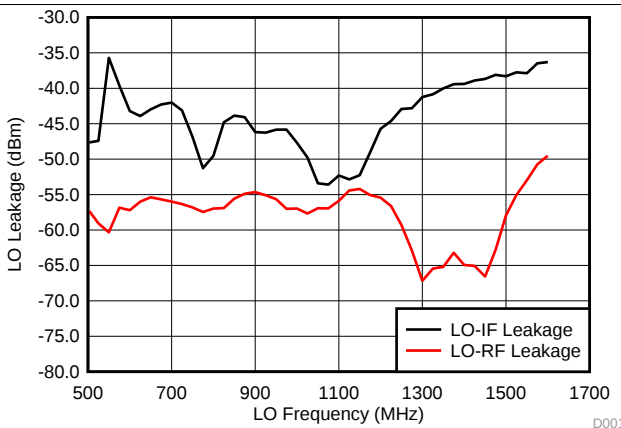


Figure 11. LO-IF/RF Leakage vs Frequency

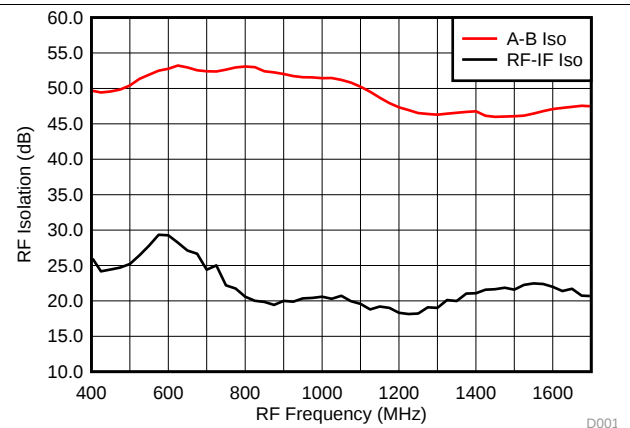


Figure 12. A-B Channel and RF-IF Isolation

Typical Characteristics (TRF37A32) (continued)

$T_A = 25^\circ\text{C}$, $V_{CC} = 3.3\text{ V}$; $P_{RF} = -10\text{ dBm}$; $F_{RF} = 950\text{ MHz}$; $P_{LO} = 0\text{ dBm}$; $F_{IF} = 200\text{ MHz}$; Low Side Injection, LPM = 0 (unless otherwise noted)

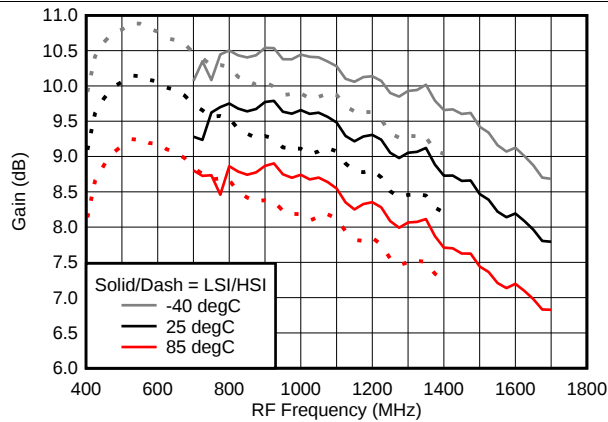


Figure 13. Gain vs Frequency over Temperature (HSI/LSI)

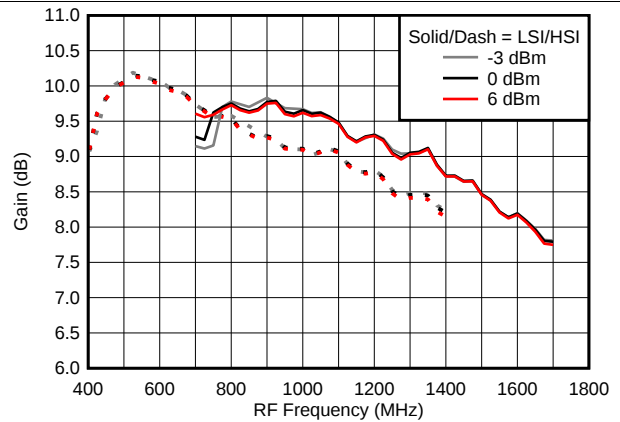


Figure 14. Gain vs Frequency over LO Drive (H/LSI)

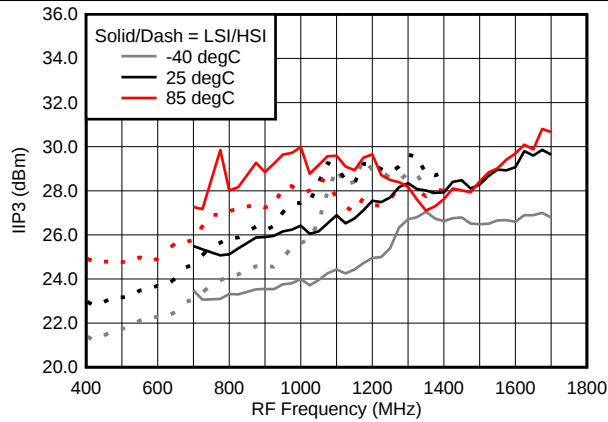


Figure 15. IIP3 vs Frequency over Temperature (HSI/LSI)

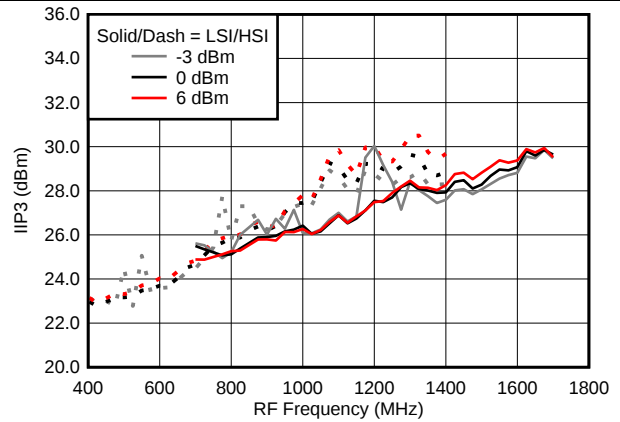


Figure 16. IIP3 vs Frequency over LO Drive (H/LSI)

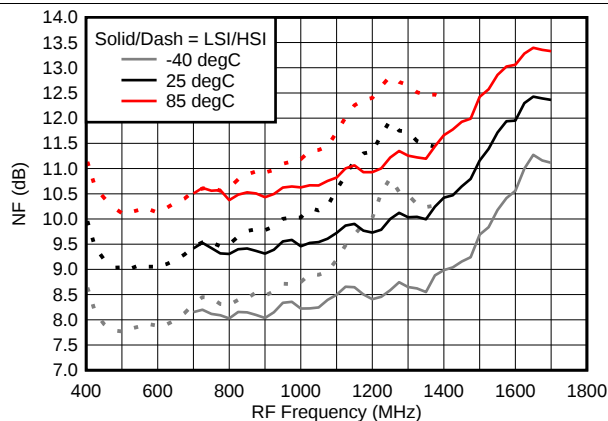


Figure 17. NF vs Frequency over Temperature (HSI/LSI)

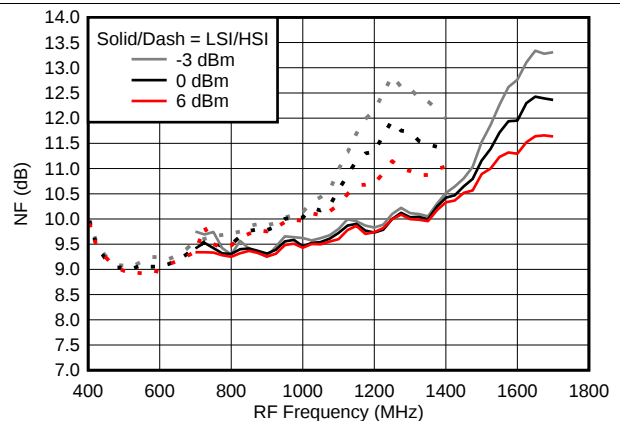


Figure 18. NF vs Frequency over LO Drive (H/LSI)

Typical Characteristics (TRF37A32) (continued)

$T_A = 25^\circ\text{C}$, $V_{CC} = 3.3\text{ V}$; $P_{RF} = -10\text{ dBm}$; $F_{RF} = 950\text{ MHz}$; $P_{LO} = 0\text{ dBm}$; $F_{IF} = 200\text{ MHz}$; Low Side Injection, LPM = 0 (unless otherwise noted)

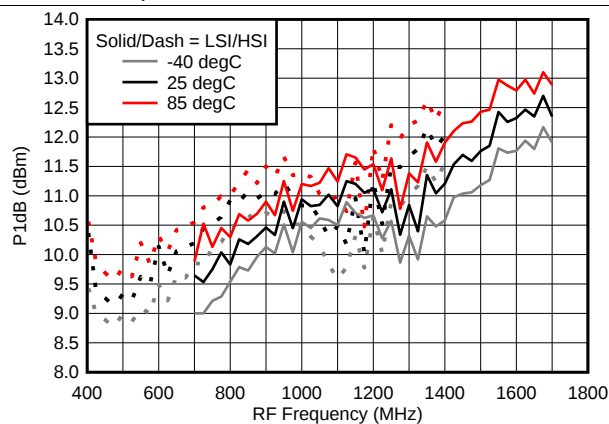


Figure 19. Input P1dB vs Frequency over Temperature (HSI/LSI)

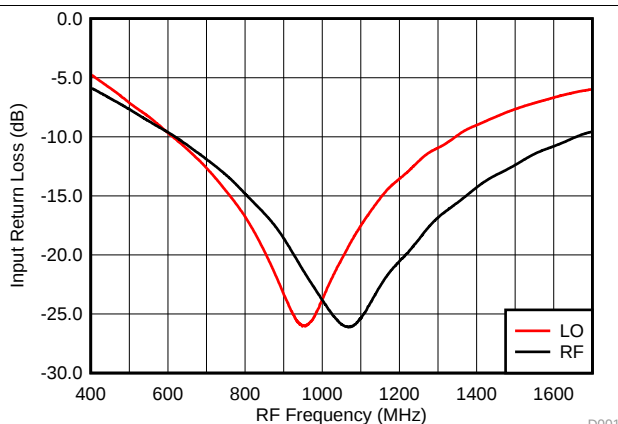


Figure 20. RF/LO Input Return Loss

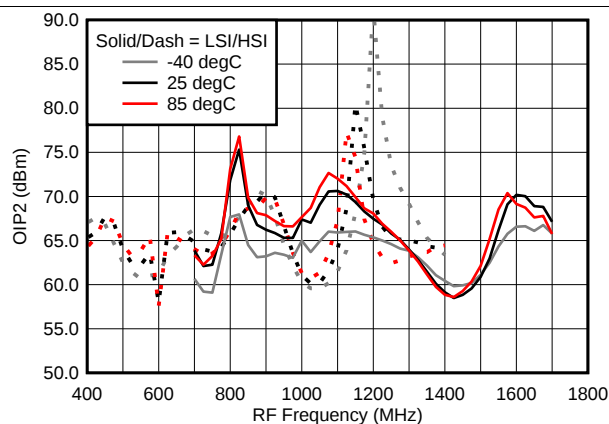


Figure 21. OIP2 vs Frequency over Temperature (HSI/LSI)

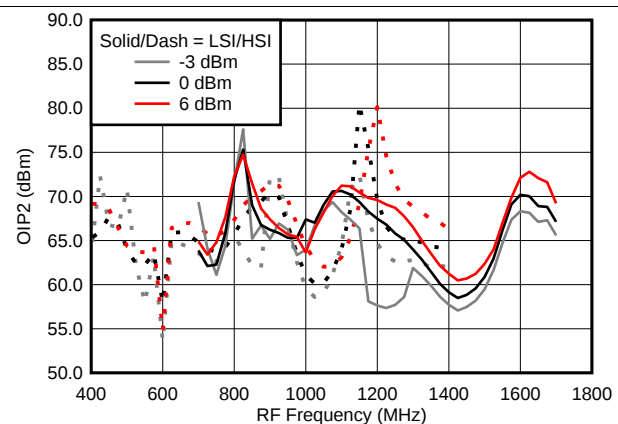


Figure 22. OIP2 vs Frequency over LO Drive (H/LSI)

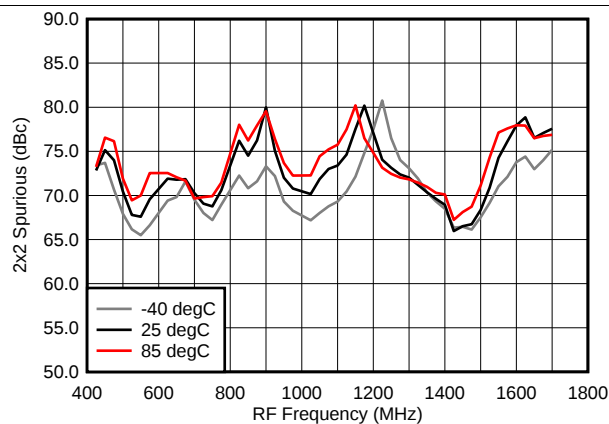


Figure 23. 2 x 2 Spurious over Temperature (H/LSI)

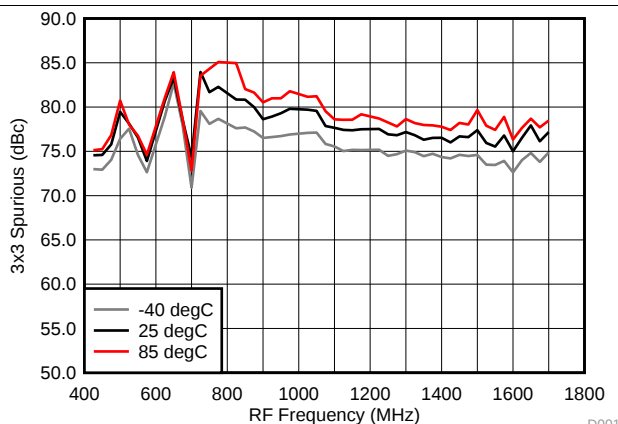


Figure 24. 3 x 3 Spurious over Temperature (H/LSI)

7.10 Typical Characteristics (TRF37B32)

$T_A = 25^\circ\text{C}$, $V_{CC} = 3.3\text{ V}$; $P_{RF} = -10\text{ dBm}$; $F_{RF} = 1950\text{ MHz}$; $P_{LO} = 0\text{ dBm}$; $F_{IF} = 200\text{ MHz}$; Low Side Injection, LPM = 0 (unless otherwise noted)

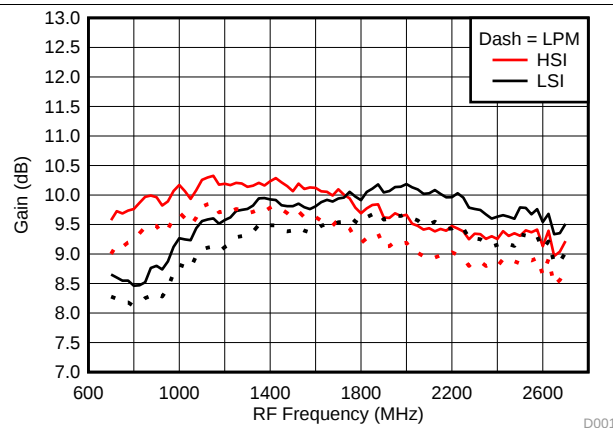


Figure 25. Gain vs Frequency over H/LSI, LPM

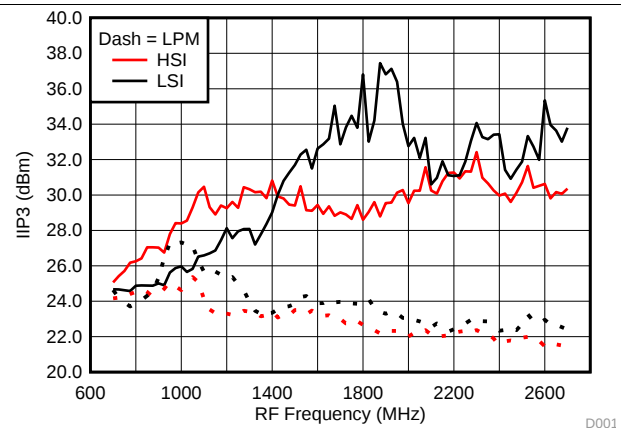


Figure 26. IIP3 vs Frequency over H/LSI, LPM

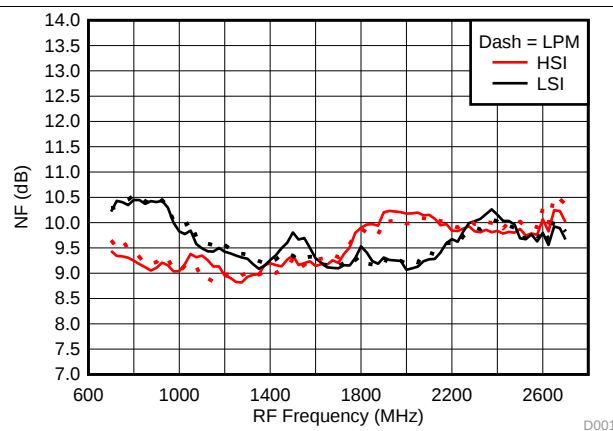


Figure 27. NF vs Frequency over H/LSI, LPM

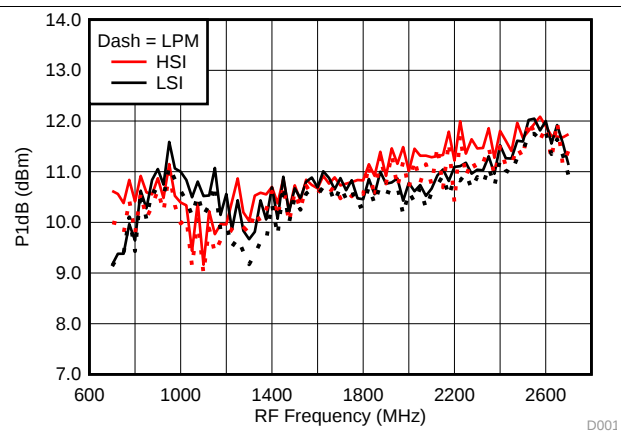


Figure 28. Input P1dB vs Frequency over H/LSI, LPM

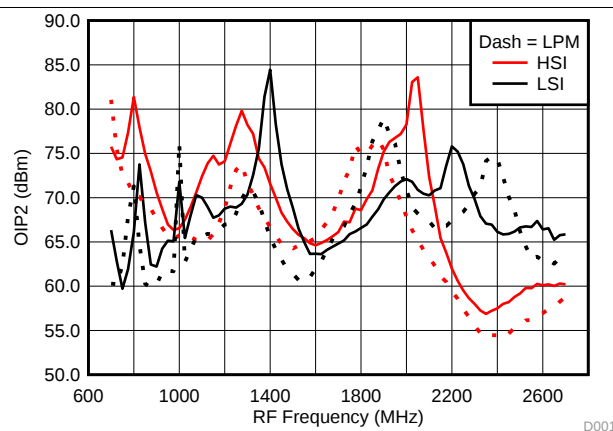


Figure 29. OIP2 vs Frequency over H/LSI, LPM

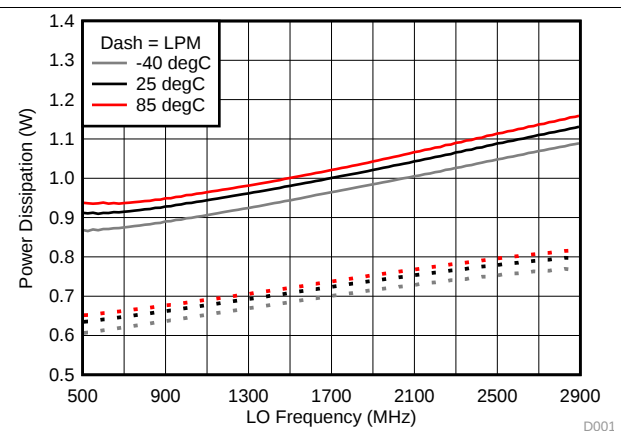


Figure 30. Power Dissipation vs Temperature, LPM

Typical Characteristics (TRF37B32) (continued)

$T_A = 25^\circ\text{C}$, $V_{CC} = 3.3\text{ V}$; $P_{RF} = -10\text{ dBm}$; $F_{RF} = 1950\text{ MHz}$; $P_{LO} = 0\text{ dBm}$; $F_{IF} = 200\text{ MHz}$; Low Side Injection, LPM = 0 (unless otherwise noted)

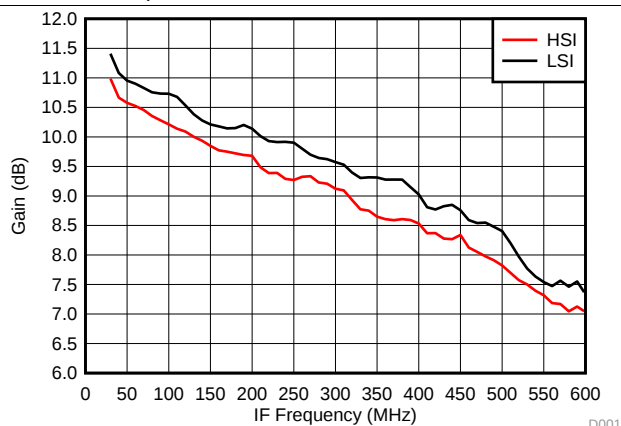


Figure 31. Gain vs IF Frequency over H/LSI

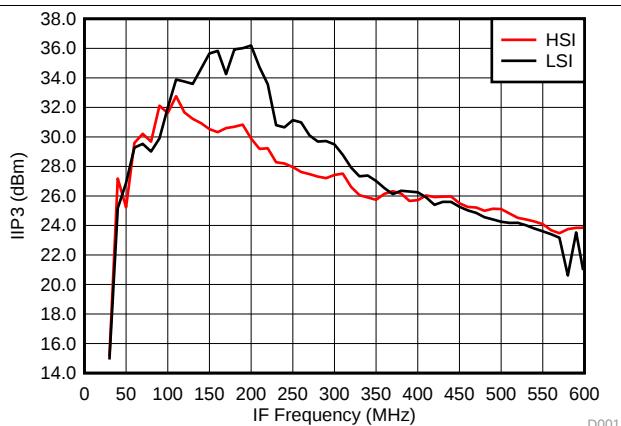


Figure 32. IIP3 vs IF Frequency over H/LSI

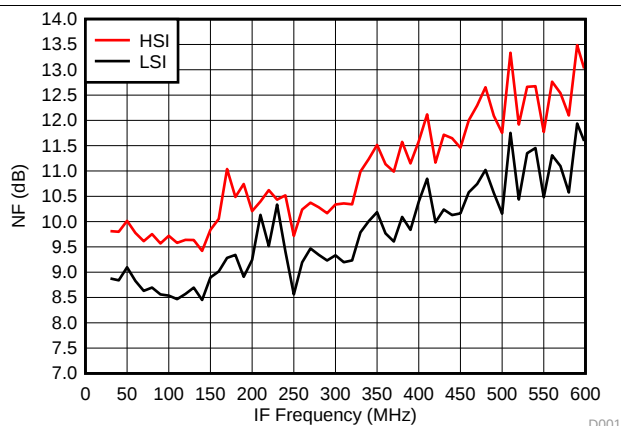


Figure 33. NF vs IF Frequency over H/LSI

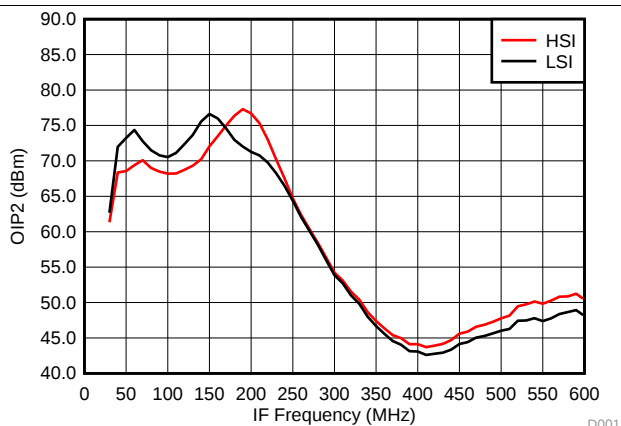


Figure 34. OIP2 vs IF Frequency over H/LSI

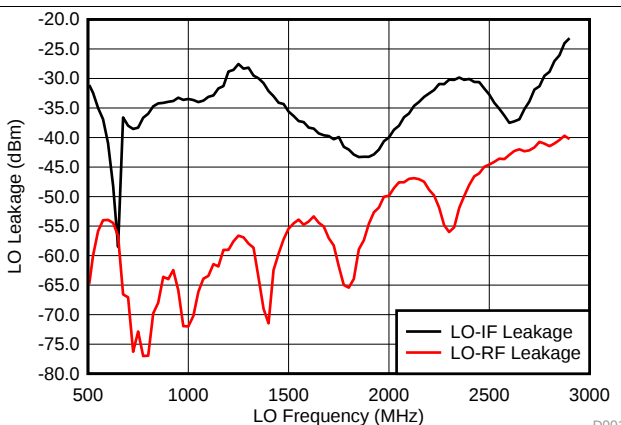


Figure 35. LO-IF/RF Leakage vs Frequency

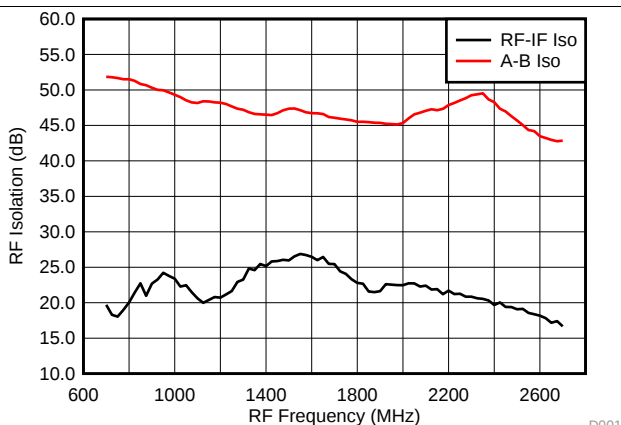


Figure 36. A-B Channel and RF-IF Isolation

Typical Characteristics (TRF37B32) (continued)

$T_A = 25^\circ\text{C}$, $V_{CC} = 3.3\text{ V}$; $P_{RF} = -10\text{ dBm}$; $F_{RF} = 1950\text{ MHz}$; $P_{LO} = 0\text{ dBm}$; $F_{IF} = 200\text{ MHz}$; Low Side Injection, LPM = 0 (unless otherwise noted)

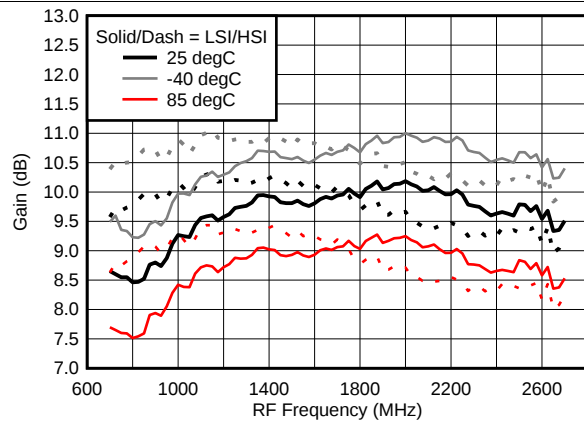


Figure 37. Gain vs Frequency over Temperature (HSI/LSI)

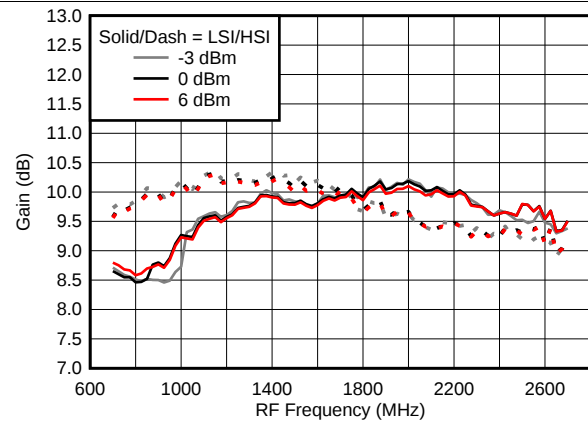


Figure 38. Gain vs Frequency over LO Drive (H/LSI)

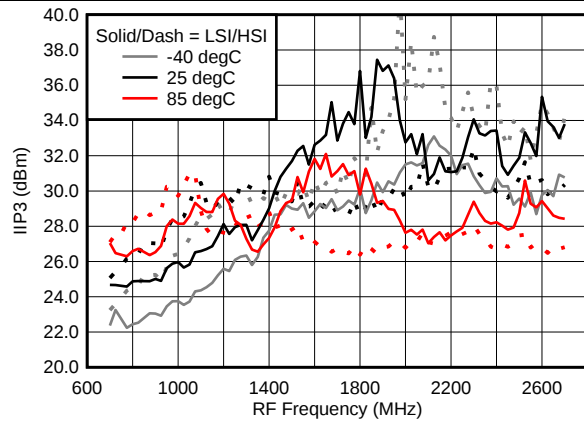


Figure 39. IIP3 vs Frequency over Temperature (HSI/LSI)

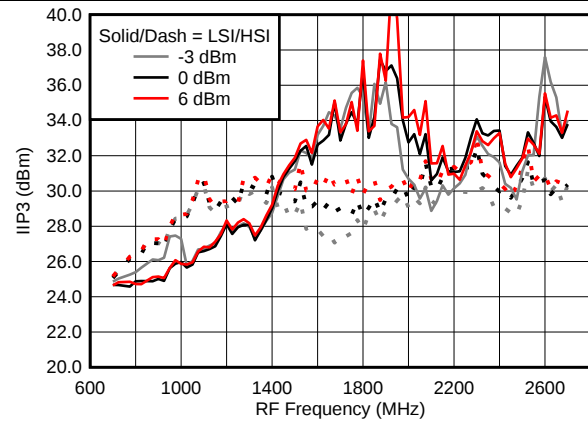


Figure 40. IIP3 vs Frequency over LO Drive (H/LSI)

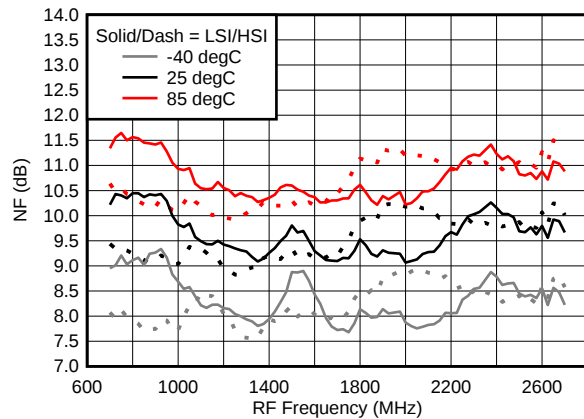


Figure 41. NF vs Frequency over Temperature (HSI/LSI)

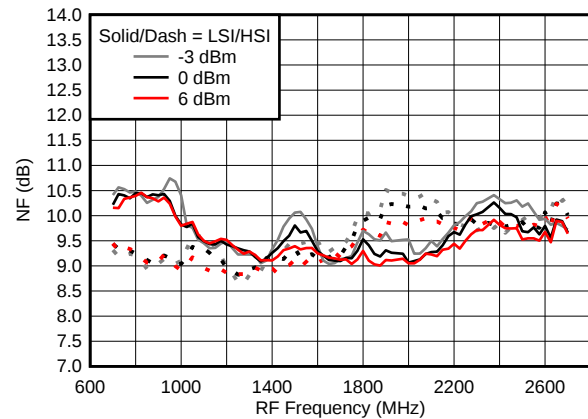


Figure 42. NF vs Frequency over LO Drive (H/LSI)

Typical Characteristics (TRF37B32) (continued)

$T_A = 25^\circ\text{C}$, $V_{CC} = 3.3\text{ V}$; $P_{RF} = -10\text{ dBm}$; $F_{RF} = 1950\text{ MHz}$; $P_{LO} = 0\text{ dBm}$; $F_{IF} = 200\text{ MHz}$; Low Side Injection, LPM = 0 (unless otherwise noted)

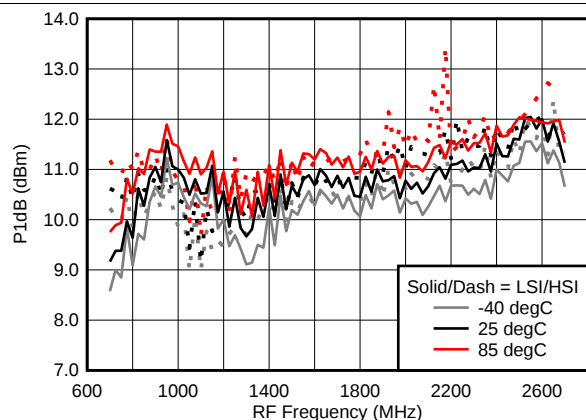


Figure 43. Input P1dB vs Frequency over Temperature (HSI/LSI)

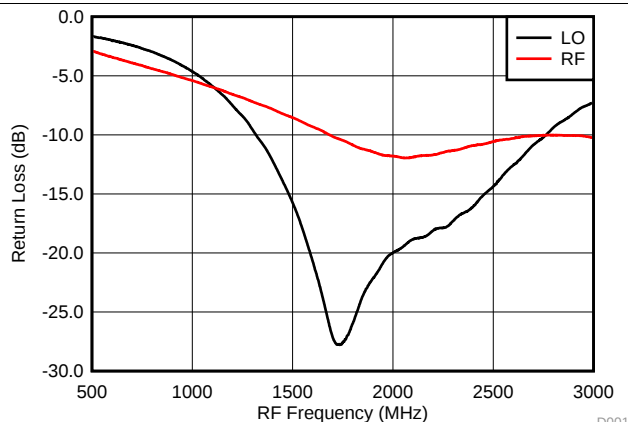


Figure 44. RF/LO Input Return Loss

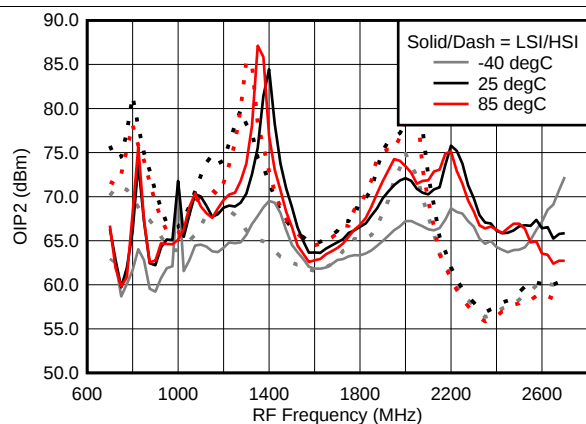


Figure 45. OIP2 vs Frequency over Temperature (HSI/LSI)

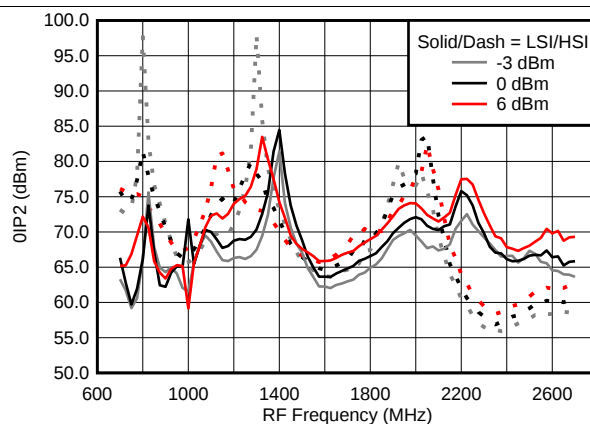


Figure 46. OIP2 vs Frequency over LO Drive (H/LSI)

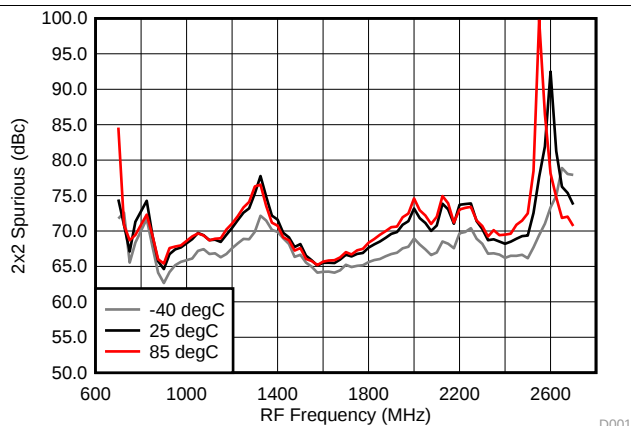


Figure 47. 2 x 2 Spurious over Temperature (H/LSI)

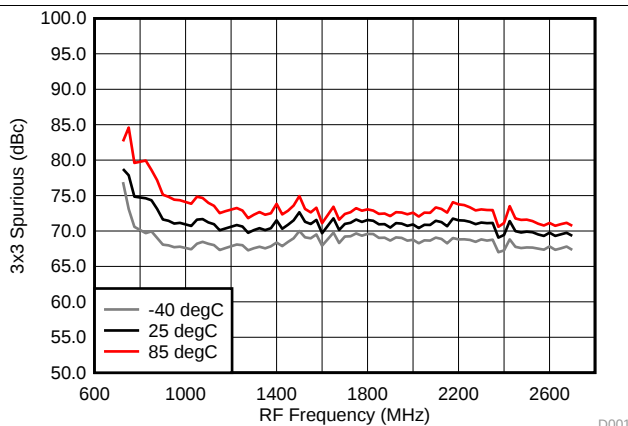


Figure 48. 3 x 3 Spurious over Temperature (H/LSI)

7.11 Typical Characteristics (TRF37C32)

$T_A = 25^\circ\text{C}$, $V_{CC} = 3.3\text{ V}$; $P_{RF} = -10\text{ dBm}$; $F_{RF} = 2500\text{ MHz}$; $P_{LO} = 0\text{ dBm}$; $F_{IF} = 200\text{ MHz}$; Low Side Injection, LPM = 0 (unless otherwise noted)

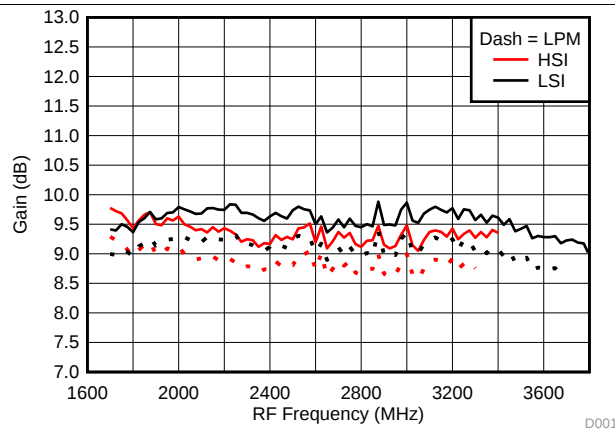


Figure 49. Gain vs Frequency over H/LSI, LPM

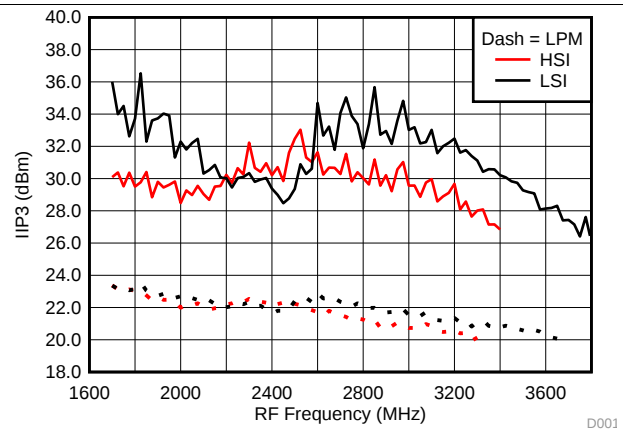


Figure 50. IIP3 vs Frequency over H/LSI, LPM

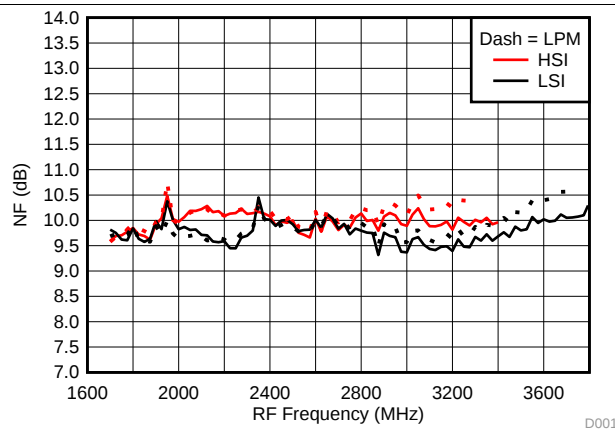


Figure 51. NF vs Frequency over H/LSI, LPM

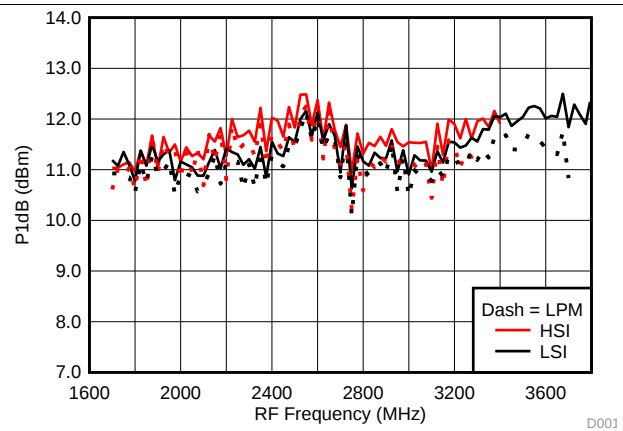


Figure 52. Input P1dB vs Frequency over H/LSI, LPM

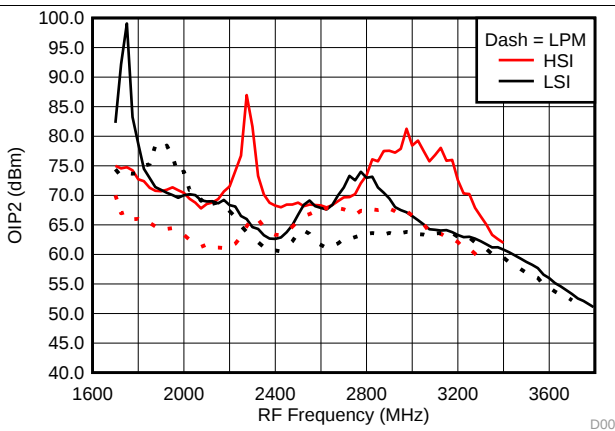


Figure 53. OIP2 vs Frequency over H/LSI, LPM

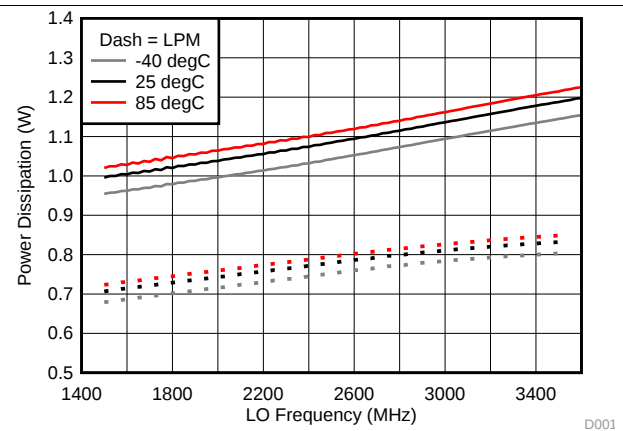


Figure 54. Power Dissipation vs Temperature, LPM

Typical Characteristics (TRF37C32) (continued)

$T_A = 25^\circ\text{C}$, $V_{CC} = 3.3\text{ V}$; $P_{RF} = -10\text{ dBm}$; $F_{RF} = 2500\text{ MHz}$; $P_{LO} = 0\text{ dBm}$; $F_{IF} = 200\text{ MHz}$; Low Side Injection, LPM = 0 (unless otherwise noted)

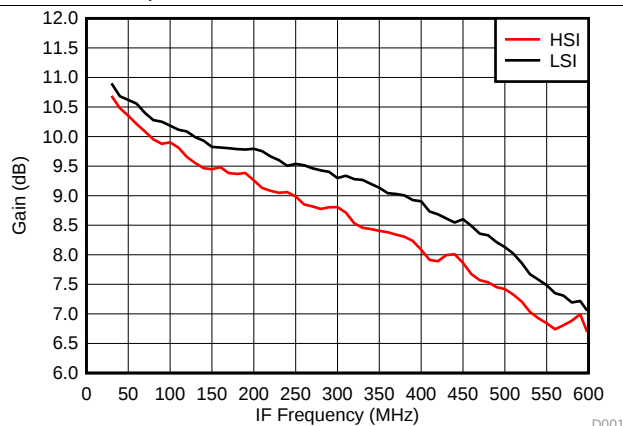


Figure 55. Gain vs IF Frequency over H/LSI

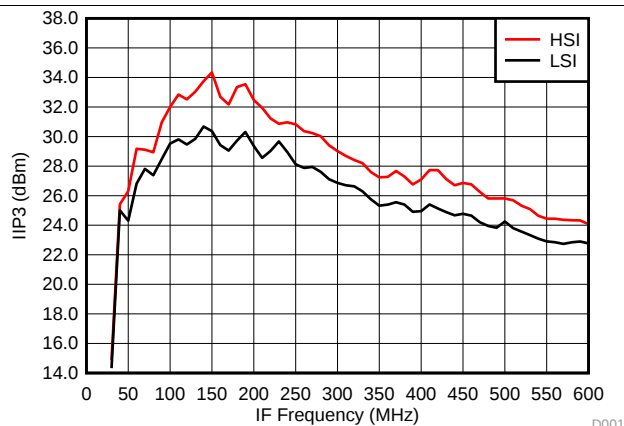


Figure 56. IIP3 vs IF Frequency over H/LSI

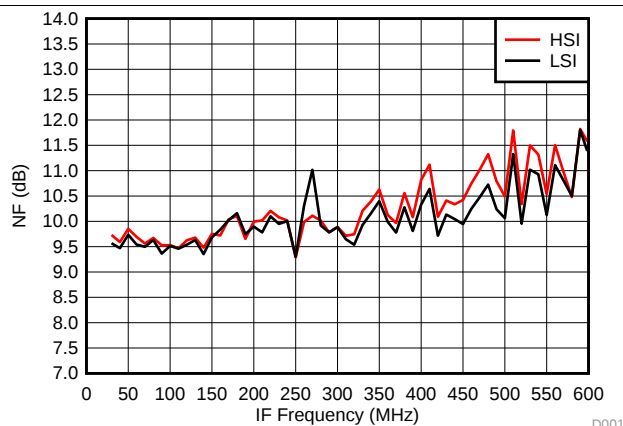


Figure 57. NF vs IF Frequency over H/LSI

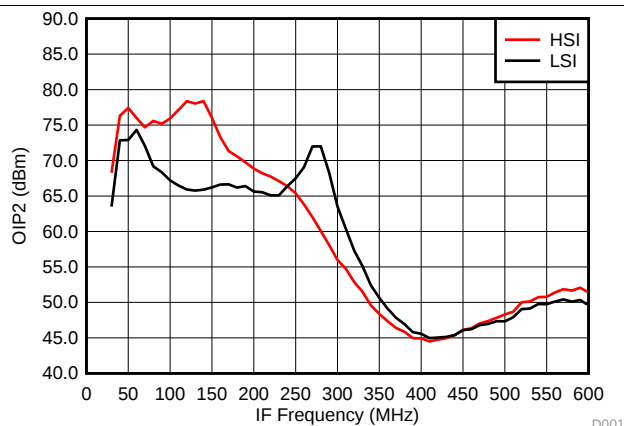


Figure 58. OIP2 vs IF Frequency over H/LSI

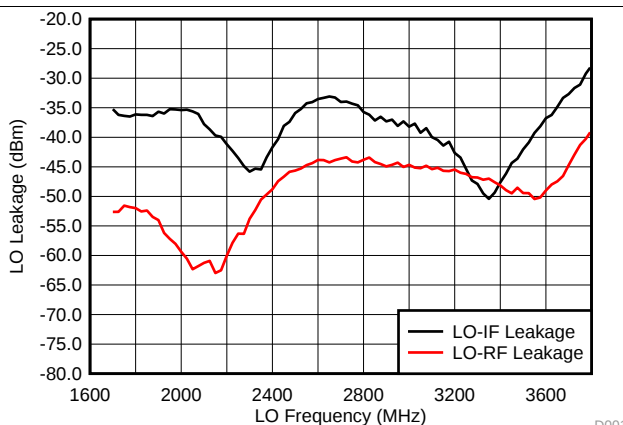


Figure 59. LO-IF/RF Leakage vs Frequency

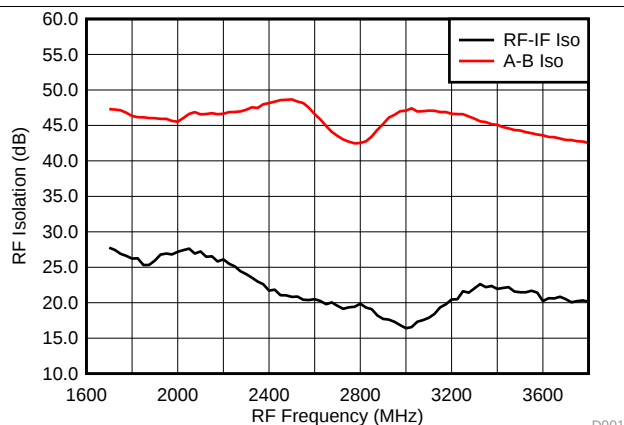


Figure 60. A-B Channel and RF-IF Isolation

Typical Characteristics (TRF37C32) (continued)

$T_A = 25^\circ\text{C}$, $V_{CC} = 3.3\text{ V}$; $P_{RF} = -10\text{ dBm}$; $F_{RF} = 2500\text{ MHz}$; $P_{LO} = 0\text{ dBm}$; $F_{IF} = 200\text{ MHz}$; Low Side Injection, LPM = 0 (unless otherwise noted)

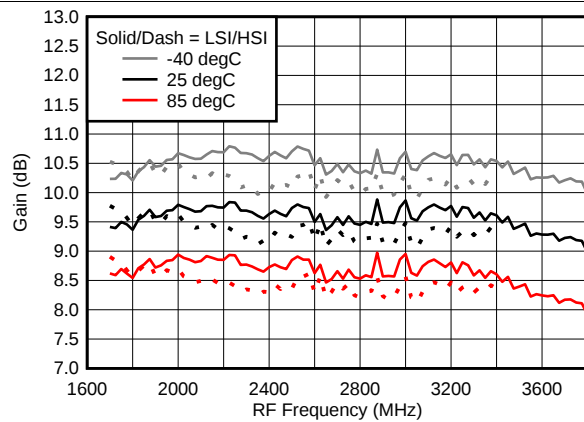


Figure 61. Gain vs Frequency over Temperature (HSI/LSI)

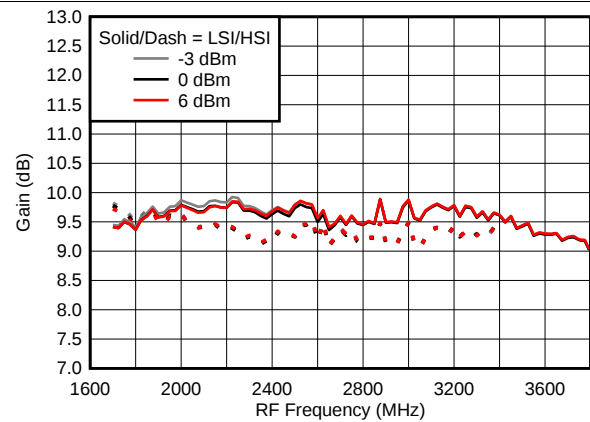


Figure 62. Gain vs Frequency over LO Drive (H/LSI)

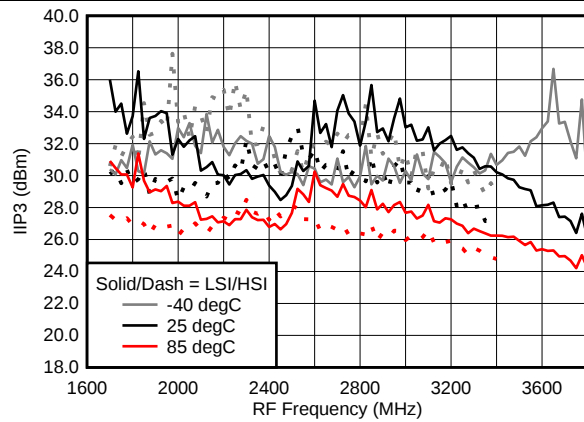


Figure 63. IIP3 vs Frequency over Temperature (HSI/LSI)

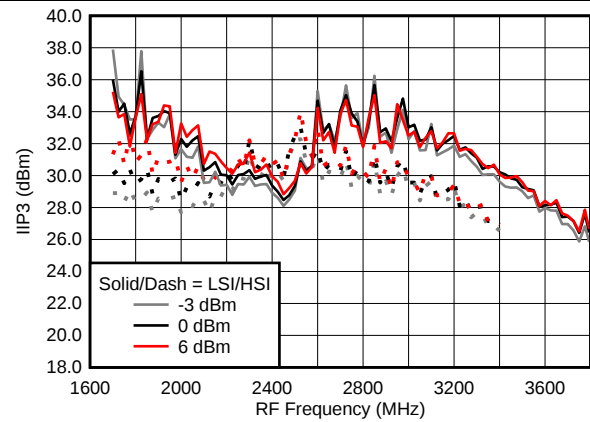


Figure 64. IIP3 vs Frequency over LO Drive (H/LSI)

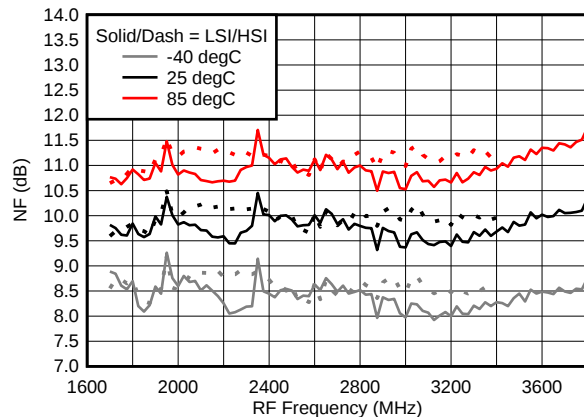


Figure 65. NF vs Frequency over Temperature (HSI/LSI)

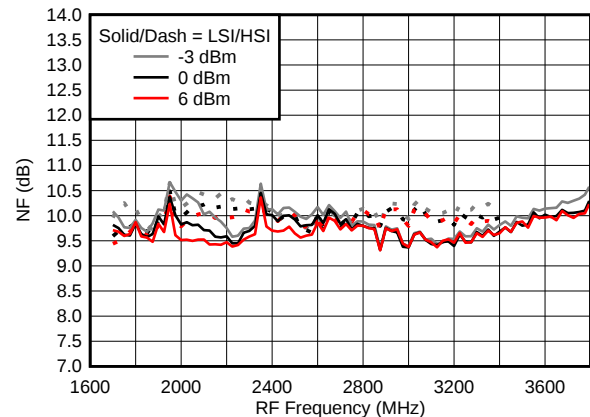


Figure 66. NF vs Frequency over LO Drive (H/LSI)

Typical Characteristics (TRF37C32) (continued)

$T_A = 25^\circ\text{C}$, $V_{CC} = 3.3\text{ V}$; $P_{RF} = -10\text{ dBm}$; $F_{RF} = 2500\text{ MHz}$; $P_{LO} = 0\text{ dBm}$; $F_{IF} = 200\text{ MHz}$; Low Side Injection, LPM = 0 (unless otherwise noted)

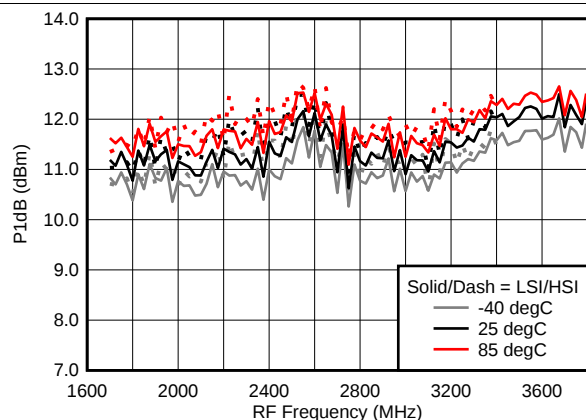


Figure 67. Input P1dB vs Frequency over Temperature (HSI/LSI)

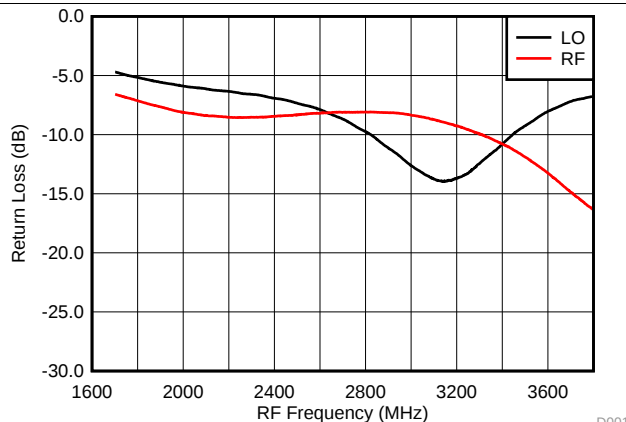


Figure 68. RF/LO Input Return Loss

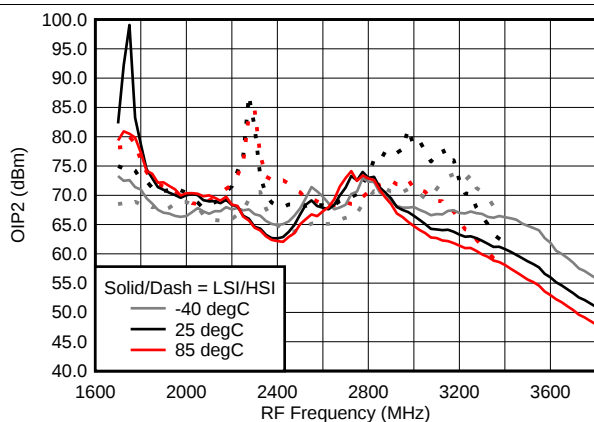


Figure 69. OIP2 vs Frequency over Temperature (HSI/LSI)

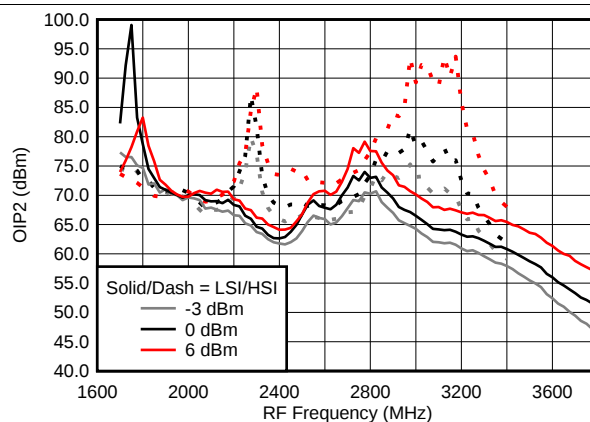


Figure 70. OIP2 vs Frequency over LO Drive (H/LSI)

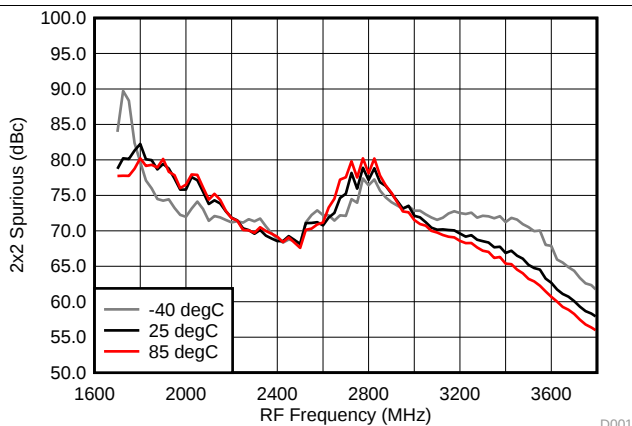


Figure 71. 2 x 2 Spurious over Temperature (H/LSI)

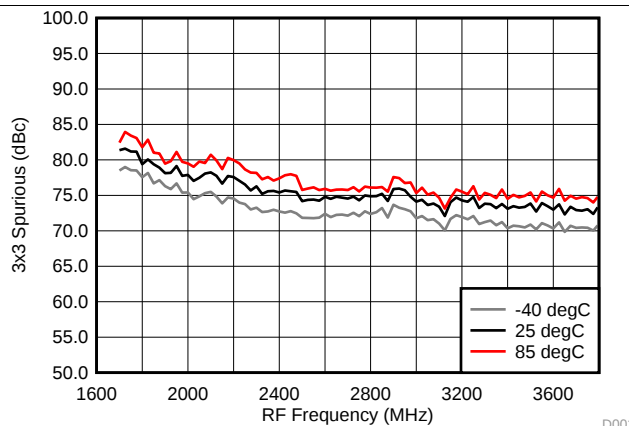


Figure 72. 3 x 3 Spurious over Temperature (H/LSI)

8.3 Feature Description

8.3.1 Low Power Mode

Low power mode is enabled by setting the active-high LPM terminal to a logic high. The device contains an internal pull-down to engage normal operation when the terminal is left unconnected or floating.

Low power mode reduces the bias current in the LO amplifier portion of the device and affects both channels. Total current consumption is reduced 30% while lowering analog performance metrics.

8.3.2 Power Down

Each channel is powered down individually through the active-high PDA and PDB terminals. A logic high sets the respective channel in power down. The device contains an internal pull-down to engage normal operation when the terminal is left unconnected or floating.

Power down is implemented by removing bias in the IF amplifier. Operation of the opposite channel is not affected when either channel is turned off. Turn-on and turn-off time is fast enough to serve in most TDD applications.

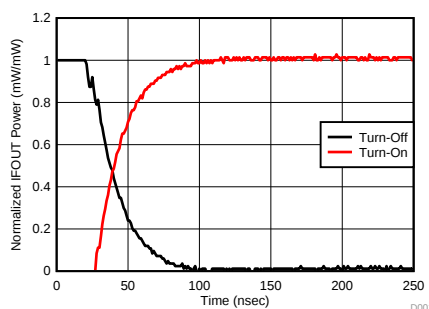


Figure 74. Device power down turn-on and turn-off time

8.3.3 Single Ended RF Input

Each RF input is single-ended with a wideband internal balun to convert the input to a differential signal, as shown in [Figure 73](#). The center tap of the balun is internally grounded and is not available external to the device. The RF input should be ac coupled to driving circuitry according to the chart in [Table 1](#).

Table 1. RF Input AC coupling capacitor

Device	Blocking Cap Value
TRF37A32	20 pF
TRF37B32	10 pF
TRF37C32	10 pF

8.3.4 Single Ended LO Input

The LO input is single ended with an internal balun to convert the input to a differential signal. The LO drive path includes a high frequency dual-mode oscillation inhibitor circuitry to ensure stable operation. For best operation it is recommended to keep the LO drive level at 0 dBm or higher to ensure inhibitor circuit does not falsely engage. At lower LO drive level, keep the LO power engaged to the device at power-up. At lower drive level the inhibitor may engage within certain frequency bands when the LO power transitions.

At the extreme RF frequencies the LO input bandwidth will force operation to either high side injection (HSI) or low side injection (LSI). [Table 2](#) provides the operating range of the LO for each device.

Table 2. LO Input Frequency Operating Range

Device	Operating Range
TRF37A32	600 - 1400 MHz
TRF37B32	500 - 2900 MHz

Table 2. LO Input Frequency Operating Range (continued)

	Device	Operating Range
TRF37C32	Low Power mode (LPM) disabled	1500 - 3600 MHz
	Low Power mode (LPM) enabled	1500 - 3500 MHz

8.3.5 IF Amplifier

The output of the device is driven by a high-linearity IF amplifier. The output nodes must be pulled up to VCC with high-Q inductors. It is designed to provide 200 Ω differential / 100 Ω single-ended output impedance. Layout should include symmetry for the differential output signal paths.

The IF output circuitry is optimized for performance at 200 MHz but operates over 30 MHz – 600 MHz.

8.4 Device Functional Modes

8.4.1 Low Power Mode

Low power mode is activated through the low power terminal, as described in the features description. It is designed for extremely low power consumption.

8.4.2 Single Channel and Shutdown Modes

The device may be operated as a single channel device by disabling one channel or in complete shutdown by disabling both channels.

9 Applications and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

The devices are high-linearity, wideband receive mixers. They are typically implemented to convert frequencies from the range 400 MHz to 3800 MHz into the range 30 MHz to 600 MHz.

9.2 Typical Application

The TRF37x32 device is typically placed in a system as illustrated in [Figure 75](#).

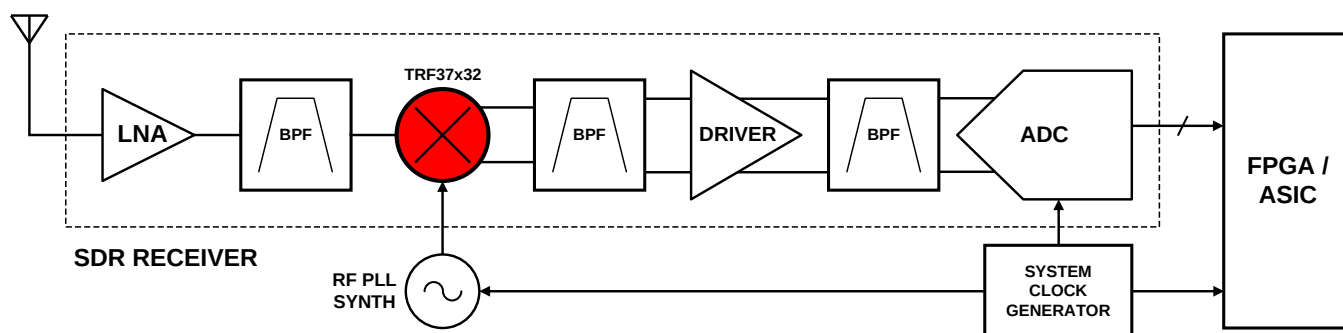


Figure 75. Typical System Implementation of TRF37x32

A typical schematic for the TRF37x32 is shown in [Figure 76](#).

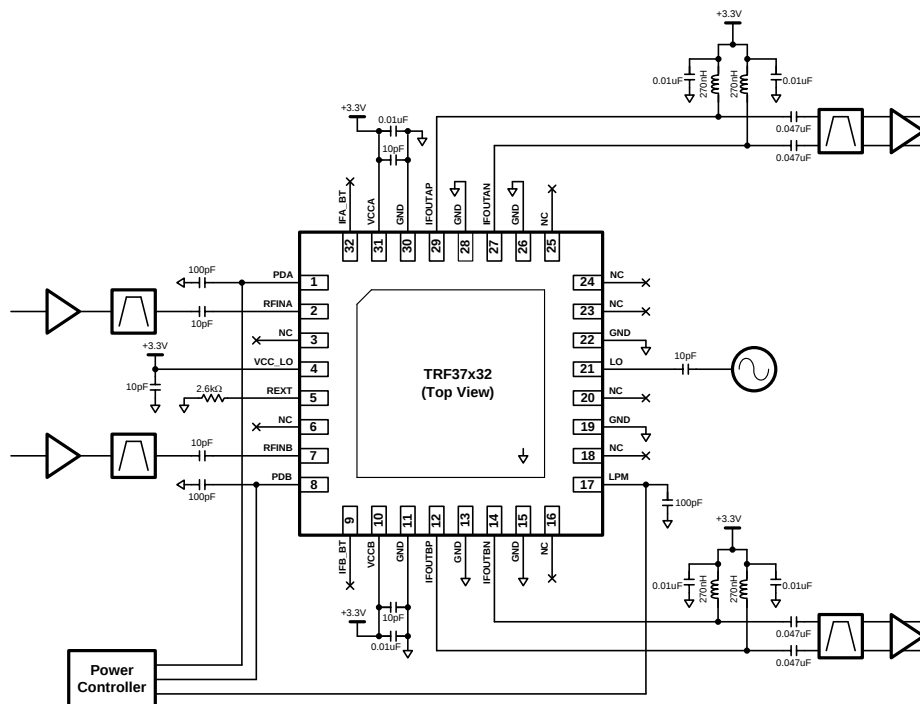


Figure 76. Typical Application Schematic for TRF37x32

Typical Application (continued)

9.2.1 Design Requirements

For this design example, use the parameters shown in [Table 3](#).

Table 3. Design Parameters

MIXER PARAMETER	EXAMPLE APPLICATION REQUIREMENTS ⁽¹⁾	TRF37B32 PERFORMANCE (TYPICAL)
RF Frequency Range	2300 - 2400 MHz	700 - 2700 MHz
IF Frequency Range	318.64 - 418.64 MHz	30 - 600 MHz
Gain	9 - 10 dB	9.7 dB at $F_{RF} = 2300$ MHz
NF	< 12 dB	10 dB at $F_{RF} = 2300$ MHz
IIP3	> 28 dBm	30 dBm at $F_{RF} = 2300$ MHz
IP1dB	> 8 dBm	11 dBm at $F_{RF} = 2300$ MHz

(1) The example application requirements are derived from a hypothetical application and do not reflect the performance of the TRF37x32.

9.2.2 Detailed Design Procedure

9.2.2.1 Power Level

Input power should back off from the TRF37x32 compression point for linear operation, ideally by 10dB or more. Choose LNA gain and gain scheduling in order to set the appropriate power level at the RF input to the TRF37x32.

Given the expected input power level, use the expected gain through the mixer and other elements, such as SAW filter and matching networks, to calculate the voltage expected at the ADC. Adjust gain and loss elements to maximize the utilization of ADC dynamic range.

9.2.2.2 Matching

Although the TRF37x32 was designed to interface with 50 Ω RF and LO and 200 Ω differential signal lines, some elements in the signal chain may not present a wideband real impedance. Matching components are optional but may be used at these ports to improve impedance alignment, thereby increasing power delivered to the RF node and decreasing reflected and radiated power. Good matching maximizes isolation and linearity performance.

9.2.2.3 RF Input Component Selection

The blocking capacitor value on the RF input should be selected according to [Table 1](#).

9.2.2.4 IF Output Component Selection

Use high Q inductors for pull-up biasing on the IF output. 270 nH 0805-size wirewound inductors provides excellent linearity and gain. Larger inductor values may compress the IF bandwidth, while smaller package sizes tend to introduce lower inductor Q ratings.

Connect the supply nodes of both inductors for a given channel symmetrically to the VCC net with close proximity to ensure balanced connection to the supply.

9.2.2.5 Frequency Planning

The LO and RF inputs are both designed for wideband behavior, and either high-side or low-side injection may be used interchangeably across most of the RF band. At the extreme RF frequencies the LO input bandwidth will force operation to either high side injection (HSI) or low side injection (LSI). [Table 2](#) provides the operating range of the LO for each device. Where possible it is recommended to utilize low side injection to keep the power dissipation to a minimum.

9.2.2.6 Control Terminal Transients

Decoupling capacitors reduce terminal noise but also slow transient response. Adjust external capacitors in order to meet specified power-on and power-off response times. Apply transmission line matching techniques to achieve the fastest response times.

9.2.3 Application Curves

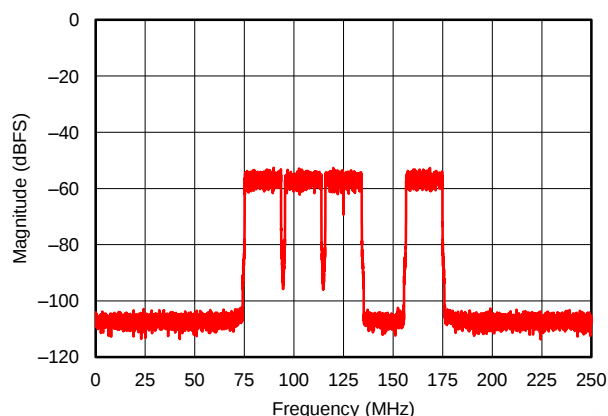


Figure 77. 4-Carrier Receiver Application

10 Power Supply Recommendations

The nominal voltage supply is 3.3 V; however, the TRF37x32 offers very consistent performance across the entire recommended voltage range. Signal isolation depends partly on power supply isolation. All supplies may be generated from a common source but should be isolated through decoupling capacitors placed close to the device. The typical application schematic in [Figure 76](#) is an excellent example. Select capacitors with self-resonant frequency near the application frequency or noise frequency. When multiple capacitors are used in parallel to create a broadband decoupling network, place the capacitor with the higher self-resonant frequency closer to the device.

10.1 Power Up Sequence

No power up sequence is required.

11 Layout

11.1 Layout Guidelines

Good layout practice helps to enable excellent linearity and isolation performance. An example of good layout is shown in [Figure 78](#). In the example, only the top signal layer and its adjacent ground reference plane are shown. Some recommended layout principles include the following:

- Excellent electrical connection from the PowerPAD™ to the board ground is essential. Use the recommended footprint, solder the pad to the board, and do not include solder mask under the pad
- Connect pad ground to device terminal ground on the top board layer.
- Verify that the return current path follows the primary current path by including topside terminal to pour ground connection and vias close to any reference layer transition.
- Do not route signal lines over breaks in the reference plane.
- Maintain symmetry as much as possible between lines in a differential pair. Match electrical lengths.
- Avoid routing clocks and digital control lines near signal lines.
- Do not route signal lines over noisy power planes. Ground is the best reference, although clean power planes can serve where necessary.
- Place supply decoupling close to the device.
- Keep channels physically separated to improve isolation.

11.2 Layout Example

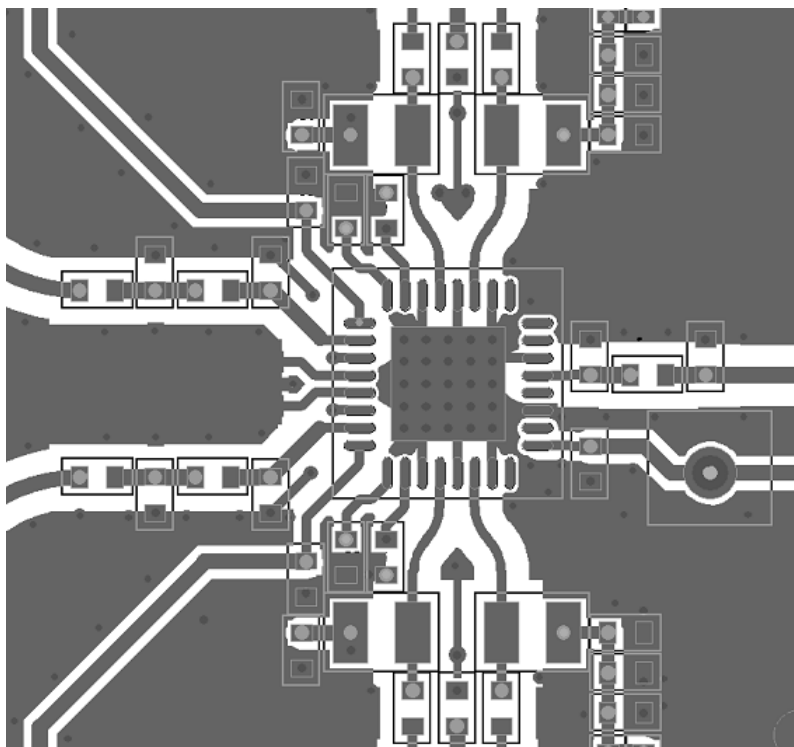


Figure 78.

12 器件和文档支持

12.1 相关链接

以下表格列出了快速访问链接。范围包括技术文档、支持与社区资源、工具和软件，并且可以快速访问样片或购买链接。

表 4. 相关链接

器件	产品文件夹	样片与购买	技术文档	工具与软件	支持与社区
TRF37A32	请单击此处	请单击此处	请单击此处	请单击此处	请单击此处
TRF37B32	请单击此处	请单击此处	请单击此处	请单击此处	请单击此处
TRF37C32	请单击此处	请单击此处	请单击此处	请单击此处	请单击此处

12.2 商标

PowerPAD is a trademark of Texas Instruments.
All other trademarks are the property of their respective owners.

12.3 静电放电警告



这些装置包含有限的内置 ESD 保护。存储或装卸时，应将导线一起截短或将装置放置于导电泡棉中，以防止 MOS 门极遭受静电损伤。

12.4 术语表

SLYZ022 — TI 术语表。

这份术语表列出并解释术语、首字母缩略词和定义。

13 机械、封装和可订购信息

以下页中包括机械、封装和可订购信息。 这些信息是针对指定器件可提供的最新数据。 这些数据会在无通知且不对本文档进行修订的情况下发生改变。 欲获得该数据表的浏览器版本，请查阅左侧的导航栏。

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TRF37A32IRTVR	Active	Production	WQFN (RTV) 32	3000 LARGE T&R	Yes	NIPDAUAG	Level-2-260C-1 YEAR	-40 to 85	TR37A32 IRTV
TRF37A32IRTVR.A	Active	Production	WQFN (RTV) 32	3000 LARGE T&R	Yes	NIPDAUAG	Level-2-260C-1 YEAR	-40 to 85	TR37A32 IRTV
TRF37A32IRTVT	Active	Production	WQFN (RTV) 32	250 SMALL T&R	Yes	NIPDAUAG	Level-2-260C-1 YEAR	-40 to 85	TR37A32 IRTV
TRF37A32IRTVT.A	Active	Production	WQFN (RTV) 32	250 SMALL T&R	Yes	NIPDAUAG	Level-2-260C-1 YEAR	-40 to 85	TR37A32 IRTV
TRF37B32IRTVR	Active	Production	WQFN (RTV) 32	3000 LARGE T&R	Yes	NIPDAUAG	Level-2-260C-1 YEAR	-40 to 85	TR37B32 IRTV
TRF37B32IRTVR.A	Active	Production	WQFN (RTV) 32	3000 LARGE T&R	Yes	NIPDAUAG	Level-2-260C-1 YEAR	-40 to 85	TR37B32 IRTV
TRF37B32IRTVT	Active	Production	WQFN (RTV) 32	250 SMALL T&R	Yes	NIPDAUAG	Level-2-260C-1 YEAR	-40 to 85	TR37B32 IRTV
TRF37B32IRTVT.A	Active	Production	WQFN (RTV) 32	250 SMALL T&R	Yes	NIPDAUAG	Level-2-260C-1 YEAR	-40 to 85	TR37B32 IRTV
TRF37C32IRTVR	Active	Production	WQFN (RTV) 32	3000 LARGE T&R	Yes	NIPDAUAG	Level-2-260C-1 YEAR	-40 to 85	TR37C32 IRTV
TRF37C32IRTVR.A	Active	Production	WQFN (RTV) 32	3000 LARGE T&R	Yes	NIPDAUAG	Level-2-260C-1 YEAR	-40 to 85	TR37C32 IRTV
TRF37C32IRTVT	Active	Production	WQFN (RTV) 32	250 SMALL T&R	Yes	NIPDAUAG	Level-2-260C-1 YEAR	-40 to 85	TR37C32 IRTV
TRF37C32IRTVT.A	Active	Production	WQFN (RTV) 32	250 SMALL T&R	Yes	NIPDAUAG	Level-2-260C-1 YEAR	-40 to 85	TR37C32 IRTV

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TRF37A32IRTVR	WQFN	RTV	32	3000	330.0	12.4	5.3	5.3	1.5	8.0	12.0	Q2
TRF37B32IRTVR	WQFN	RTV	32	3000	330.0	12.4	5.3	5.3	1.5	8.0	12.0	Q2
TRF37C32IRTVR	WQFN	RTV	32	3000	330.0	12.4	5.3	5.3	1.5	8.0	12.0	Q2

TAPE AND REEL BOX DIMENSIONS

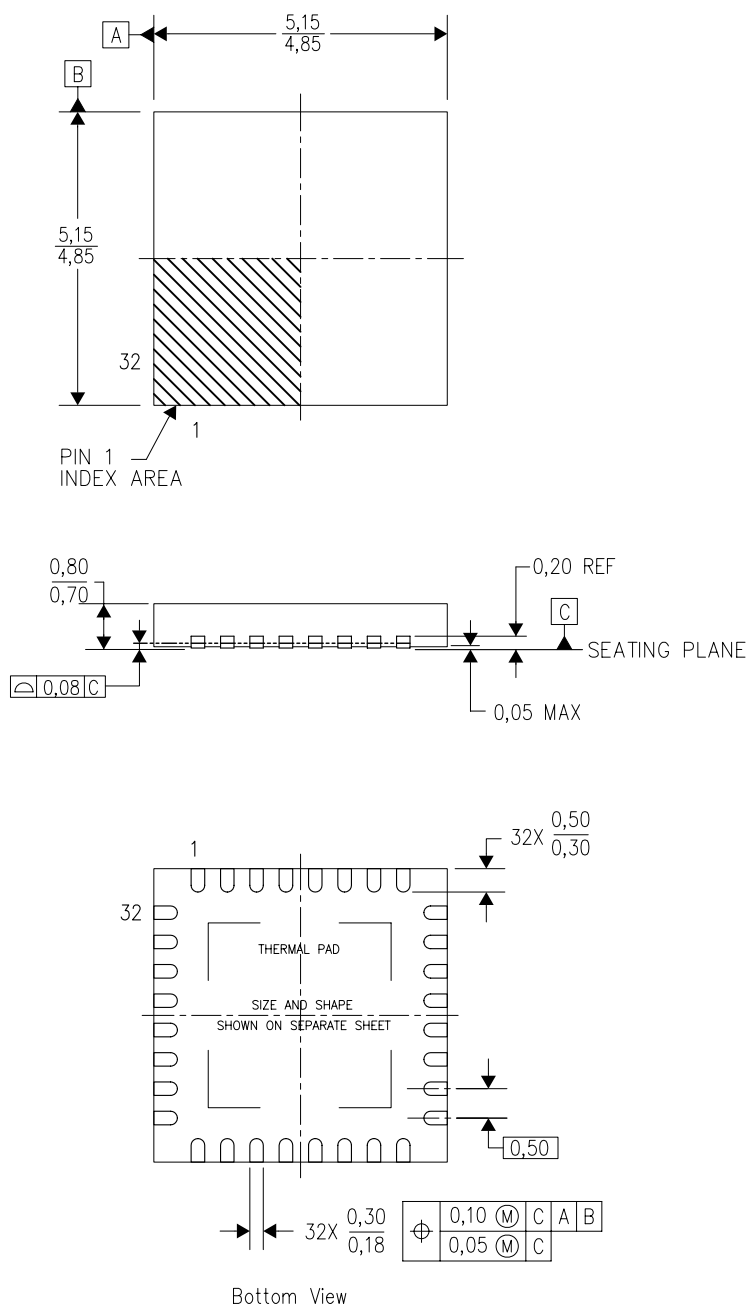


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TRF37A32IRTVR	WQFN	RTV	32	3000	350.0	350.0	43.0
TRF37B32IRTVR	WQFN	RTV	32	3000	350.0	350.0	43.0
TRF37C32IRTVR	WQFN	RTV	32	3000	350.0	350.0	43.0

RTV (S-PWQFN-N32)

PLASTIC QUAD FLATPACK NO-LEAD



4206245/C 10/11

- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5-1994.
 - B. This drawing is subject to change without notice.
 - C. Quad Flatpack, No-Leads (QFN) package configuration.
 - D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
 - E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
 - F. Falls within JEDEC MO-220.

RTV (S-PWQFN-N32)

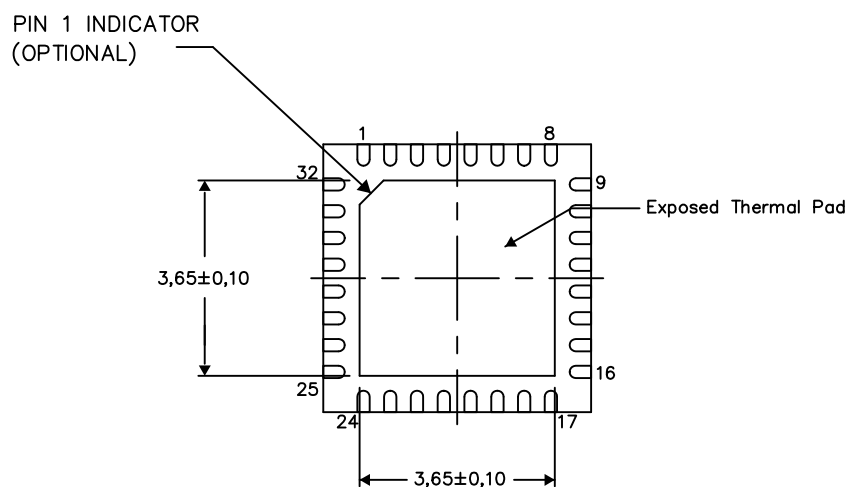
PLASTIC QUAD FLATPACK NO-LEAD

THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

Exposed Thermal Pad Dimensions

4206250-7/Q 05/15

NOTE: All linear dimensions are in millimeters

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